

Modeling of photon scanning tunneling microscopy by 2-D quadridirectional eigenmode expansion



MESA⁺

AAMP

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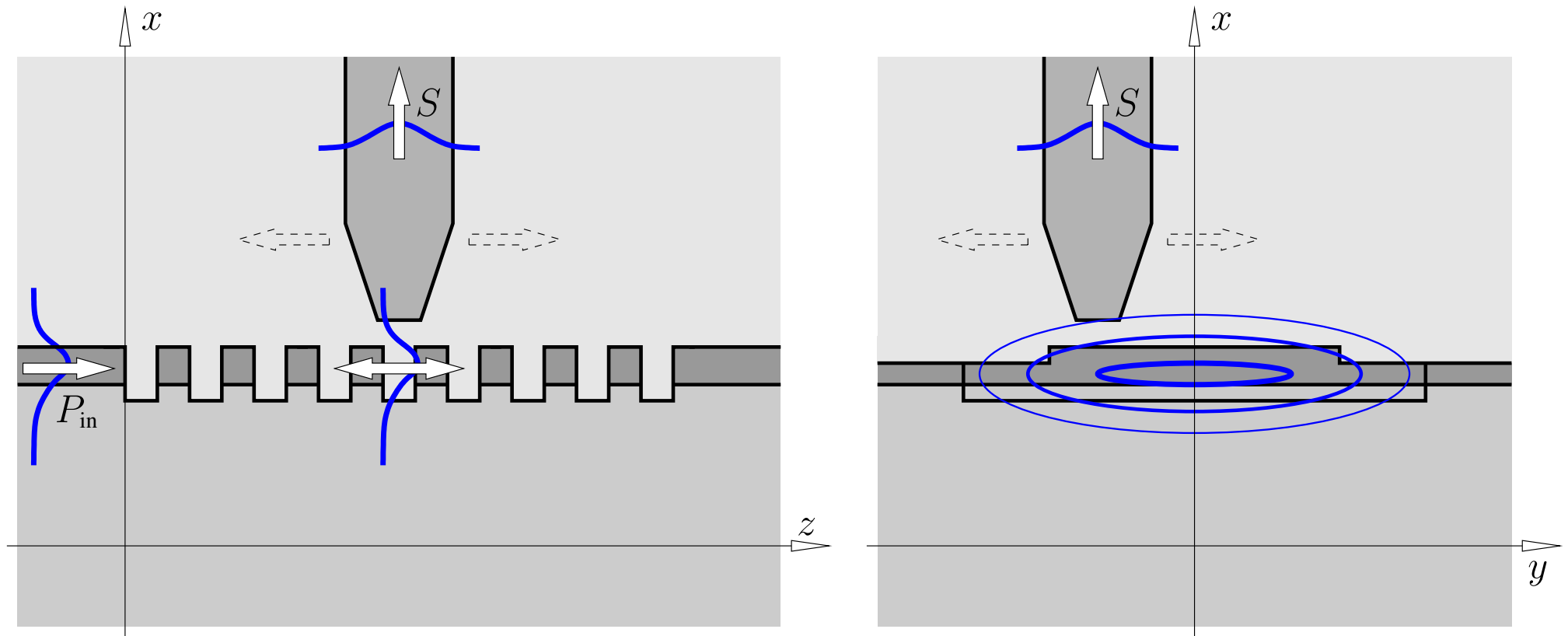
PIERS 2004, Progress in Electromagnetics Research Symposium, Pisa, Italy, 28. – 31.03.2004

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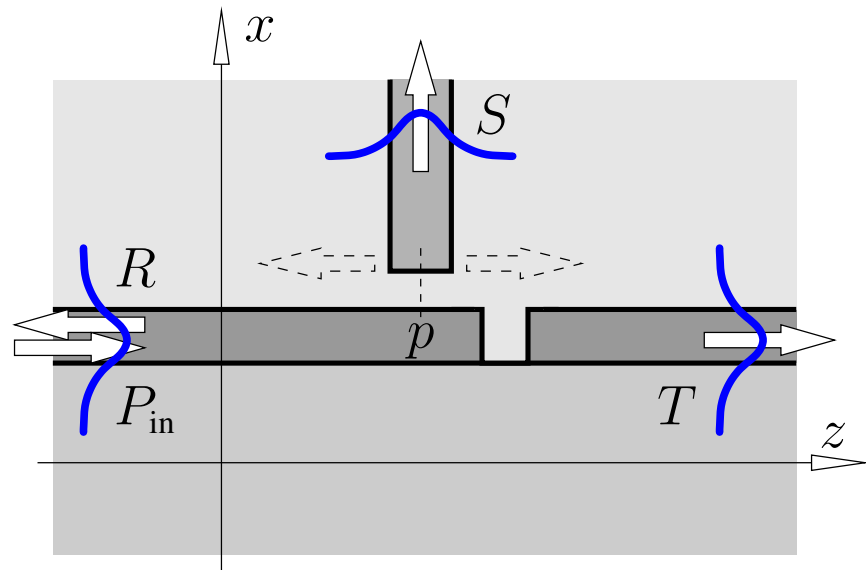
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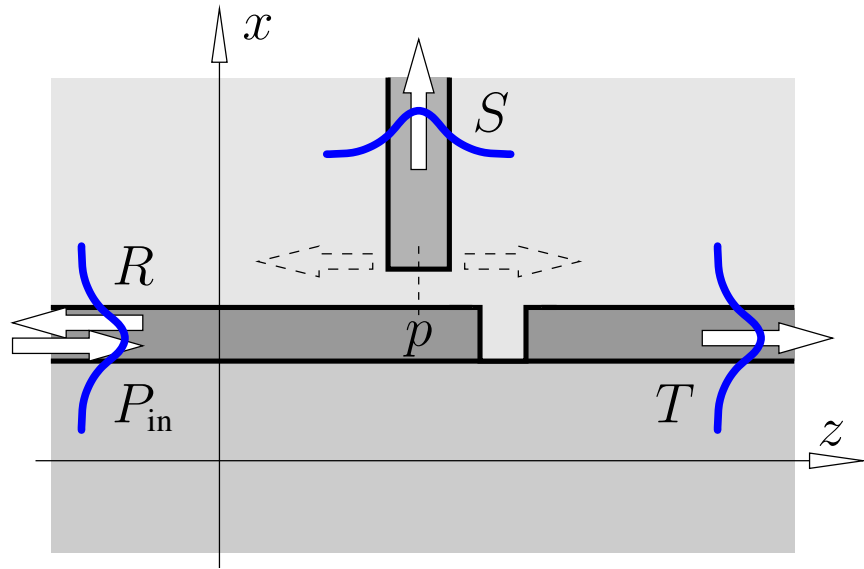
Photon scanning tunneling microscopy (PSTM) of photonic devices



Simplified 2-D model



Simplified 2-D model

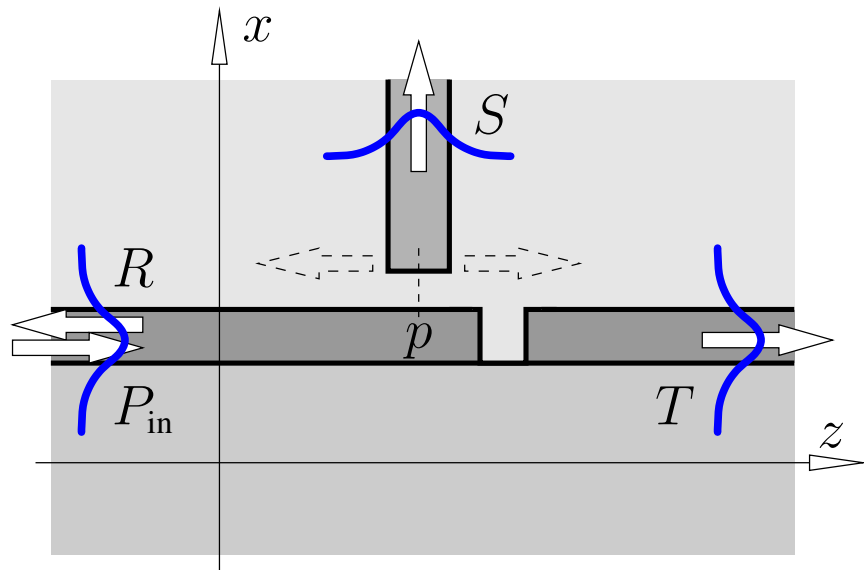


$$P_{\text{in}} = 1. \quad S(p) = ?$$

$$R(p), T(p) = ?$$

$$S(p) \overset{?}{\longleftrightarrow} (\text{optical field})|_p$$

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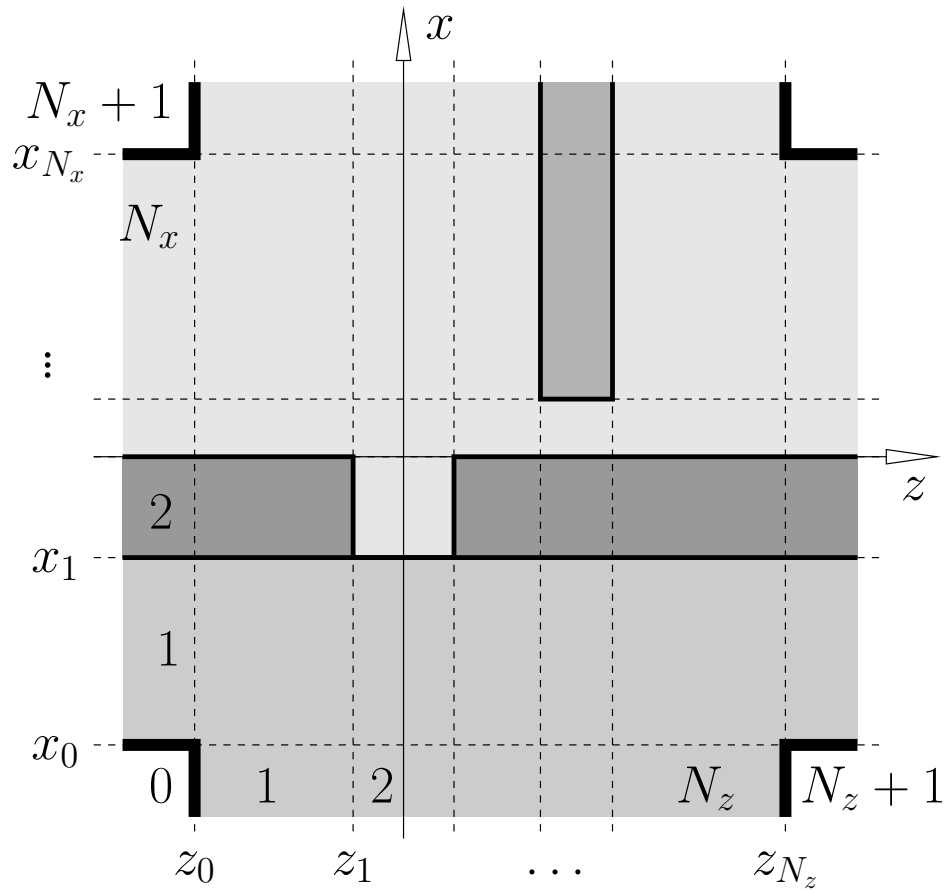
Fixed optical frequency, rectangular piecewise constant refractive index,
horizontal & vertical guided wave in- and outflux

→ *QUEP simulations*

Outline

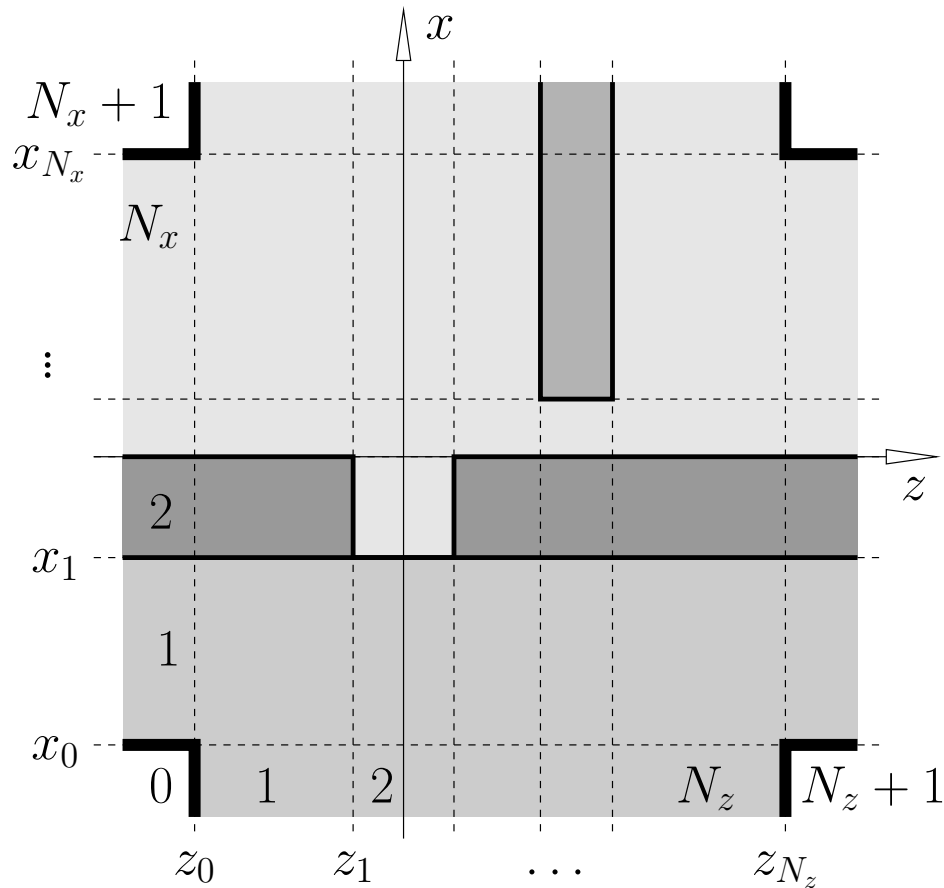
- Quadridirectional eigenmode propagation:
 - Problem setting
 - Eigenmode expansion
 - Algebraic procedure
- 2-D PSTM model, numerical results:
 - Probing evanescent fields
 - Hole defect in a slab waveguide
 - Short waveguide Bragg grating
 - Resonant defect cavity
 - Bragg grating: PSTM experiment & 2-D model

Simulations, problem setting



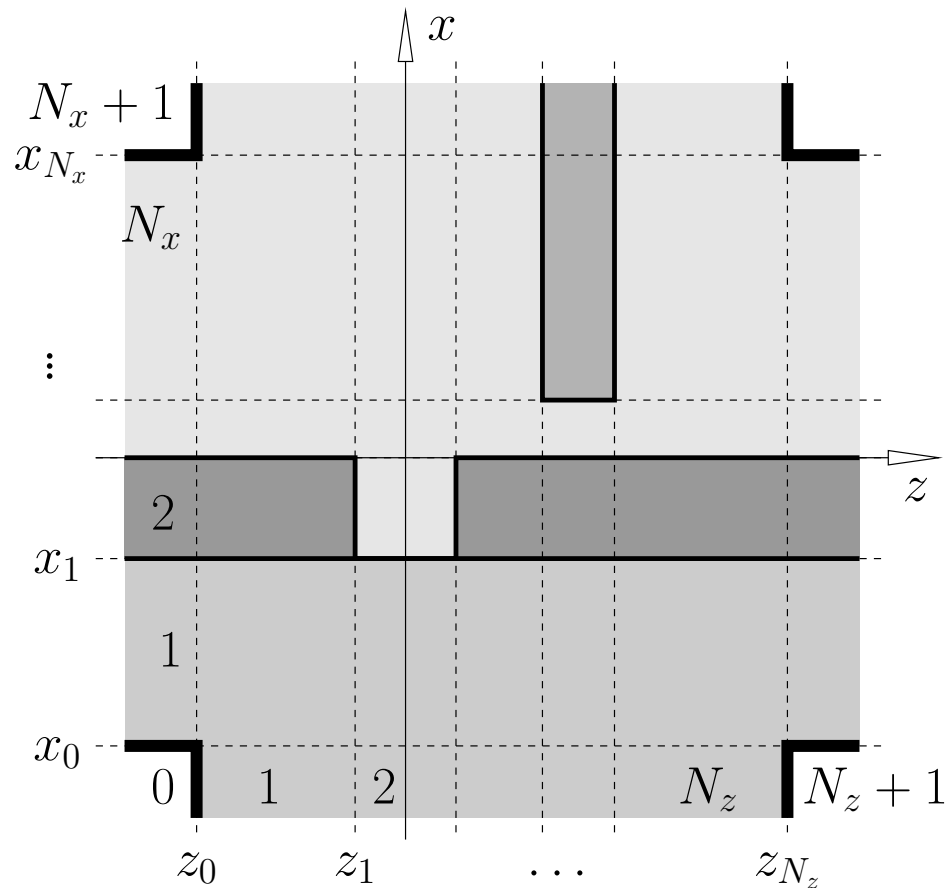
- 2-D TE/TM Helmholtz problem, vacuum wavelength $\lambda = 2\pi/k$.

Simulations, problem setting



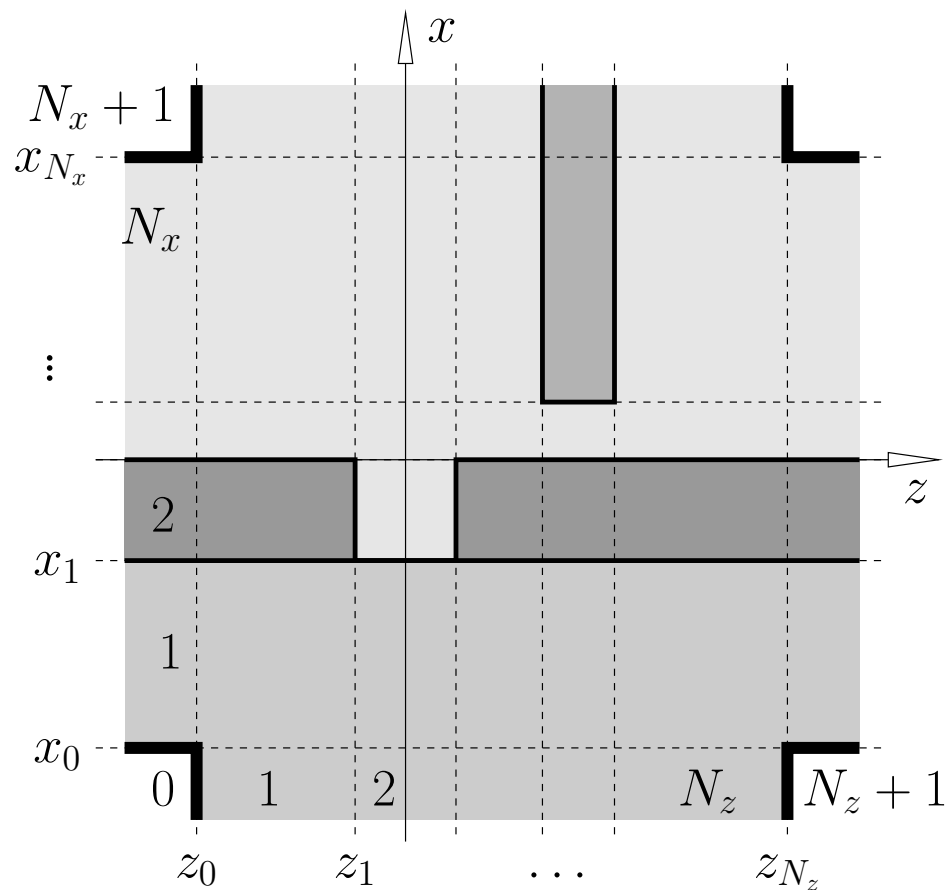
- 2-D TE/TM Helmholtz problem, vacuum wavelength $\lambda = 2\pi/k$.
- Piecewise constant, rectangular refractive index distribution; linear, lossless materials.

Simulations, problem setting



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- Rectangular interior computational domain, influx & outflux across all four boundaries, outwards homogeneous external regions.

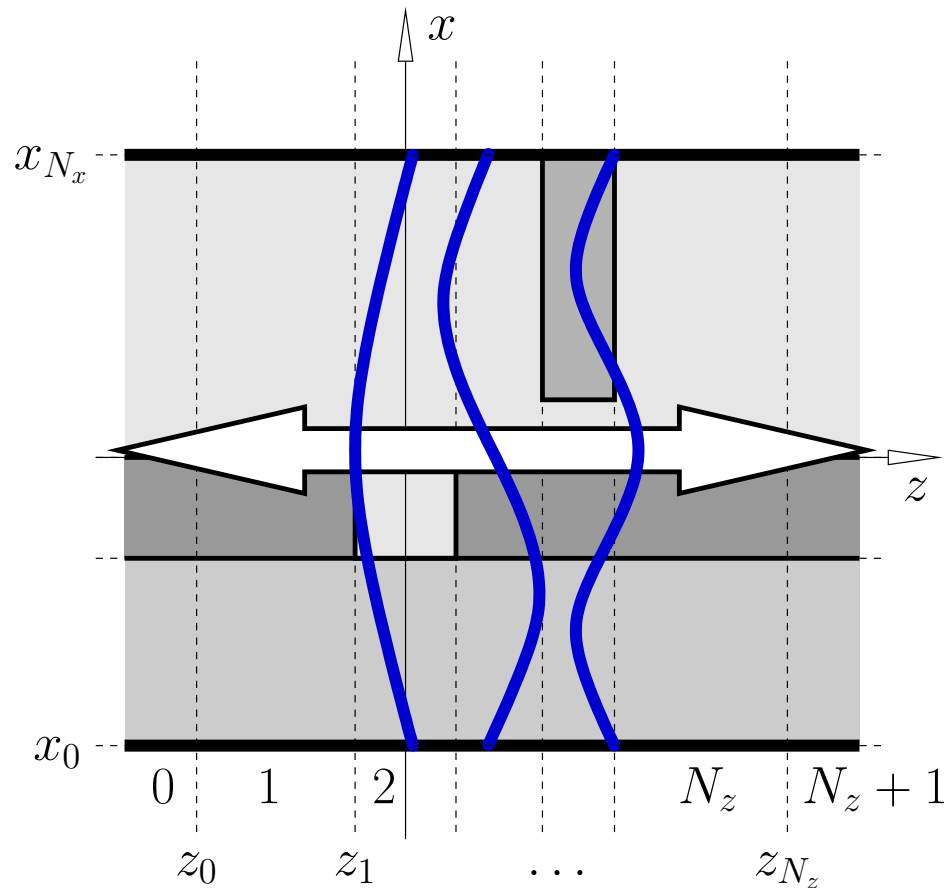
Simulations, problem setting



- 2-D TE/TM Helmholtz problem, vacuum wavelength $\lambda = 2\pi/k$.
- Piecewise constant, rectangular refractive index distribution; linear, lossless materials.
- Rectangular interior computational domain, influx & outflux across all four boundaries, outwards homogeneous external regions.
- Assumption $E_y = 0$, $H_y = 0$ on the corner points and on the external border lines is reasonable for the problems under investigation.

Modal basis fields

Basis fields,
defined by Dirichlet boundary conditions $E_y = 0$ (TE) or $H_y = 0$ (TM):



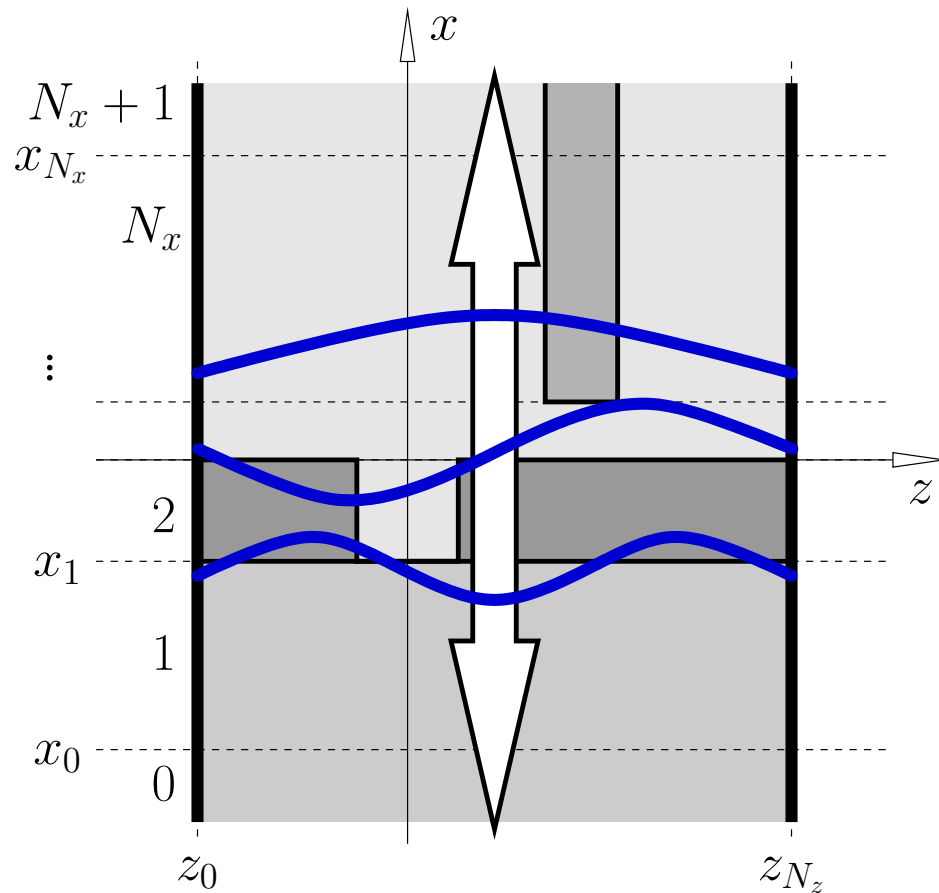
Horizontally traveling eigenmodes:

M_x profiles	$\psi_{s,m}^d(x)$
and propagation constants	$\pm\beta_{s,m}$

of order m , on slice s ,
for propagation directions $d = \text{f, b}$,

Modal basis fields

Basis fields,
defined by Dirichlet boundary conditions $E_y = 0$ (TE) or $H_y = 0$ (TM):



... and vertically traveling fields:

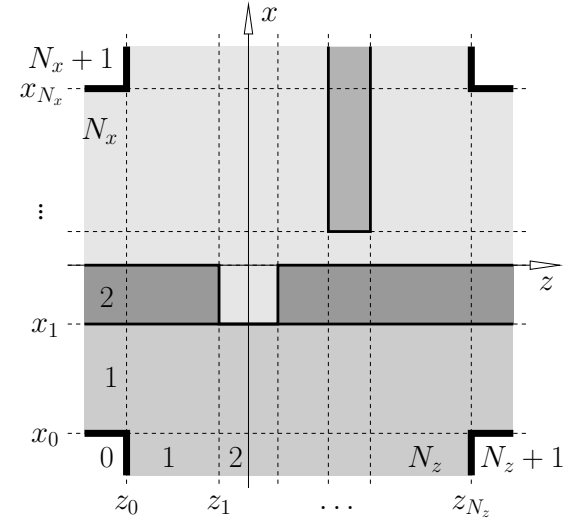
M_z profiles	$\hat{\psi}_{l,m}^d(z)$
and propagation constants	$\pm \hat{\beta}_{l,m}$

of order m , on layer l ,
for propagation directions $d = \text{u, d}$.

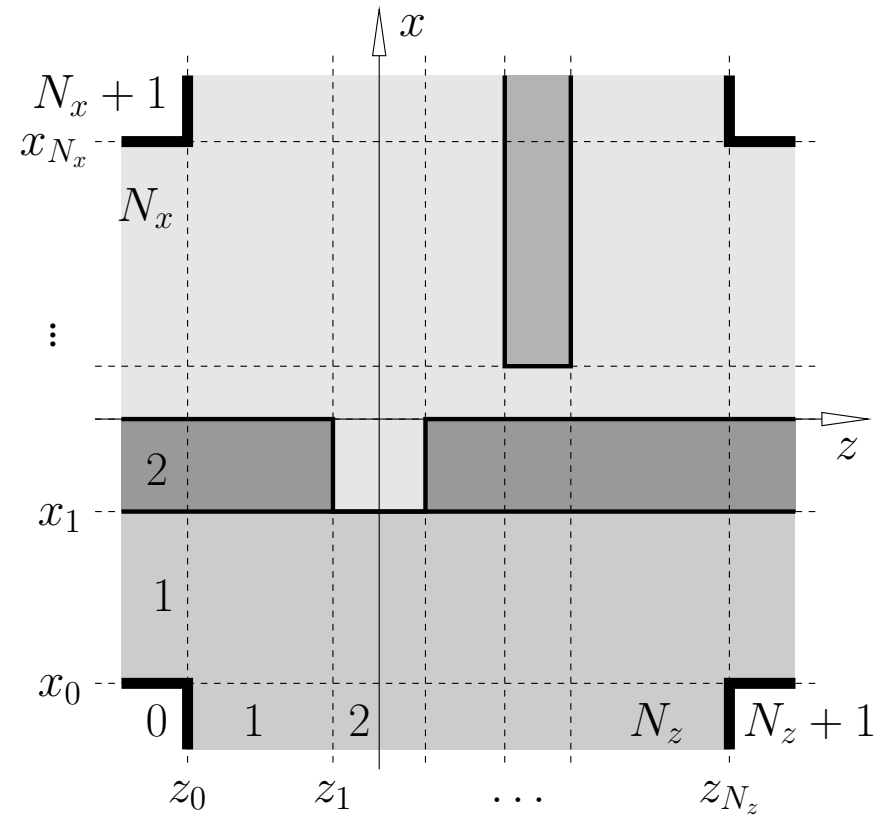
Eigenmode expansion

Ansatz for the optical field,
for $z_{s-1} \leq z \leq z_s$, $s = 1, \dots, N_z$,
and $x_{l-1} \leq x \leq x_l$, $l = 1, \dots, N_x$:

$$\begin{pmatrix} \mathcal{E} \\ \mathcal{H} \end{pmatrix} (x, z, t) = \text{Re} \left\{ \sum_{m=0}^{M_x-1} F_{s,m} \psi_{s,m}^f(x) e^{-i\beta_{s,m}(z - z_{s-1})} \right. \\ + \sum_{m=0}^{M_x-1} B_{s,m} \psi_{s,m}^b(x) e^{+i\beta_{s,m}(z - z_s)} \\ + \sum_{m=0}^{M_z-1} U_{l,m} \hat{\psi}_{l,m}^u(z) e^{-i\hat{\beta}_{l,m}(x - x_{l-1})} \\ \left. + \sum_{m=0}^{M_z-1} D_{l,m} \hat{\psi}_{l,m}^d(z) e^{+i\hat{\beta}_{l,m}(x - x_l)} \right\} e^{i\omega t}.$$



Eigenmode expansion

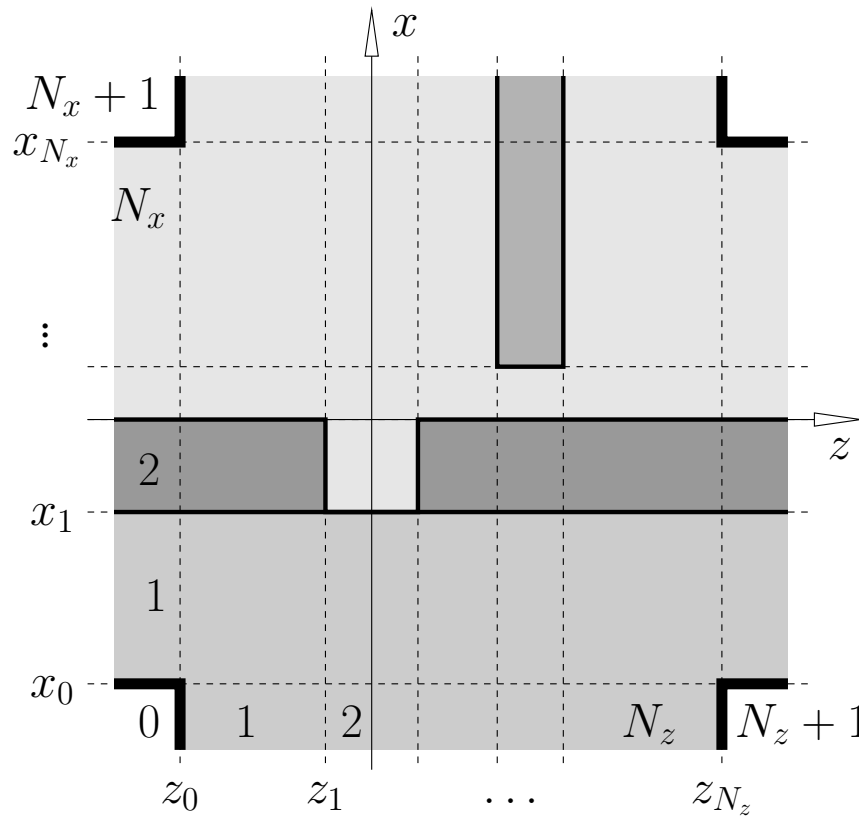


Mode products \leftrightarrow normalization, projection:

$$(\mathbf{E}_1, \mathbf{H}_1; \mathbf{E}_2, \mathbf{H}_2) = \frac{1}{4} \int (E_{1,x}^* H_{2,y} - E_{1,y}^* H_{2,x} + H_{1,y}^* E_{2,x} - H_{1,x}^* E_{2,y}) dx ,$$

$$\langle \mathbf{E}_1, \mathbf{H}_1; \mathbf{E}_2, \mathbf{H}_2 \rangle = \frac{1}{4} \int (E_{1,y}^* H_{2,z} - E_{1,z}^* H_{2,y} + H_{1,z}^* E_{2,y} - H_{1,y}^* E_{2,z}) dz .$$

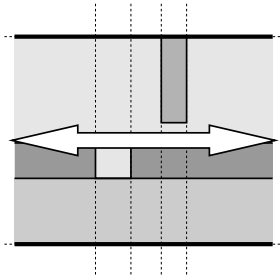
Algebraic procedure



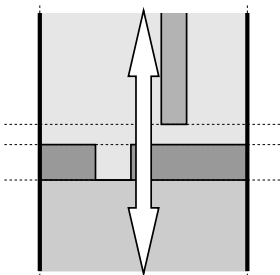
- Consistent bidirectional projection at all interfaces
 \longrightarrow linear system of equations in $\{F_{s,m}, B_{s,m}, U_{l,m}, D_{l,m}\}$.
- Influx: $F_0, B_{N_x+1}, U_0, D_{N_z+1} \longrightarrow$ RHS, given.
- Outflux: $B_0, F_{N_x+1}, D_0, U_{N_z+1} \longrightarrow$ primary unknowns.

Algebraic procedure

- “Exact” mode profiles \longrightarrow interior problems decouple:

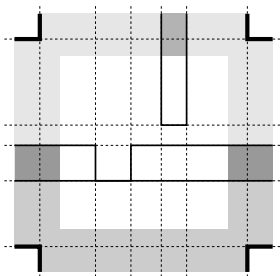


Solve for F_2, \dots, F_{N_z} and B_1, \dots, B_{N_z-1}
in terms of F_1 and B_{N_z} \longrightarrow BEP I.



Solve for U_2, \dots, U_{N_x} and D_1, \dots, D_{N_x-1}
in terms of U_1 and D_{N_x} \longrightarrow BEP II.

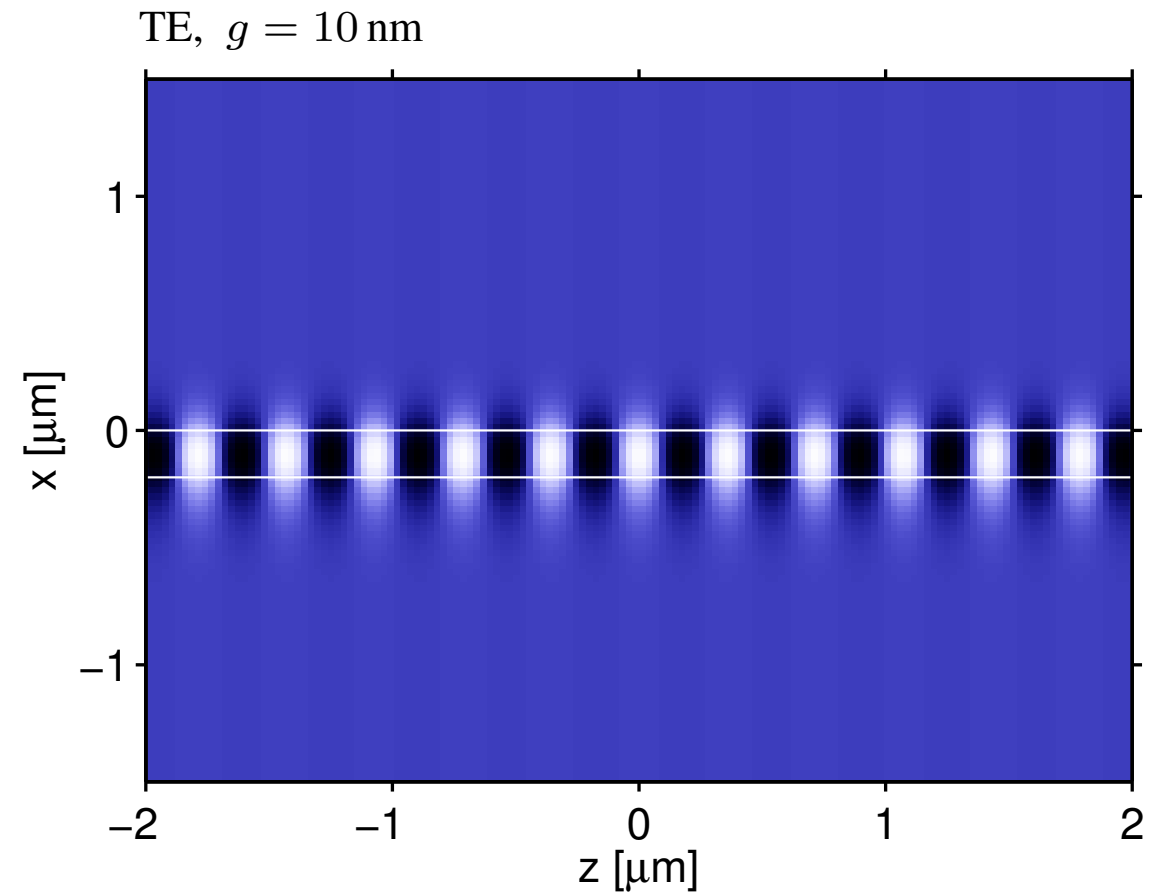
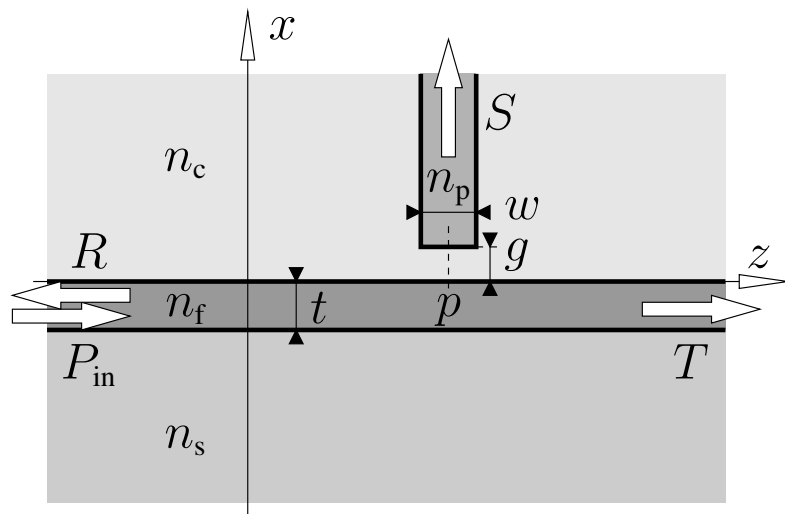
- Continuity of E and H on outer interfaces:



Interior BEP solutions
+ equations at $z = z_0, z_{N_z}, x = x_0, x_{N_x}$
 $\longrightarrow B_0, F_{N_x+1}, D_0, U_{N_z+1}$.

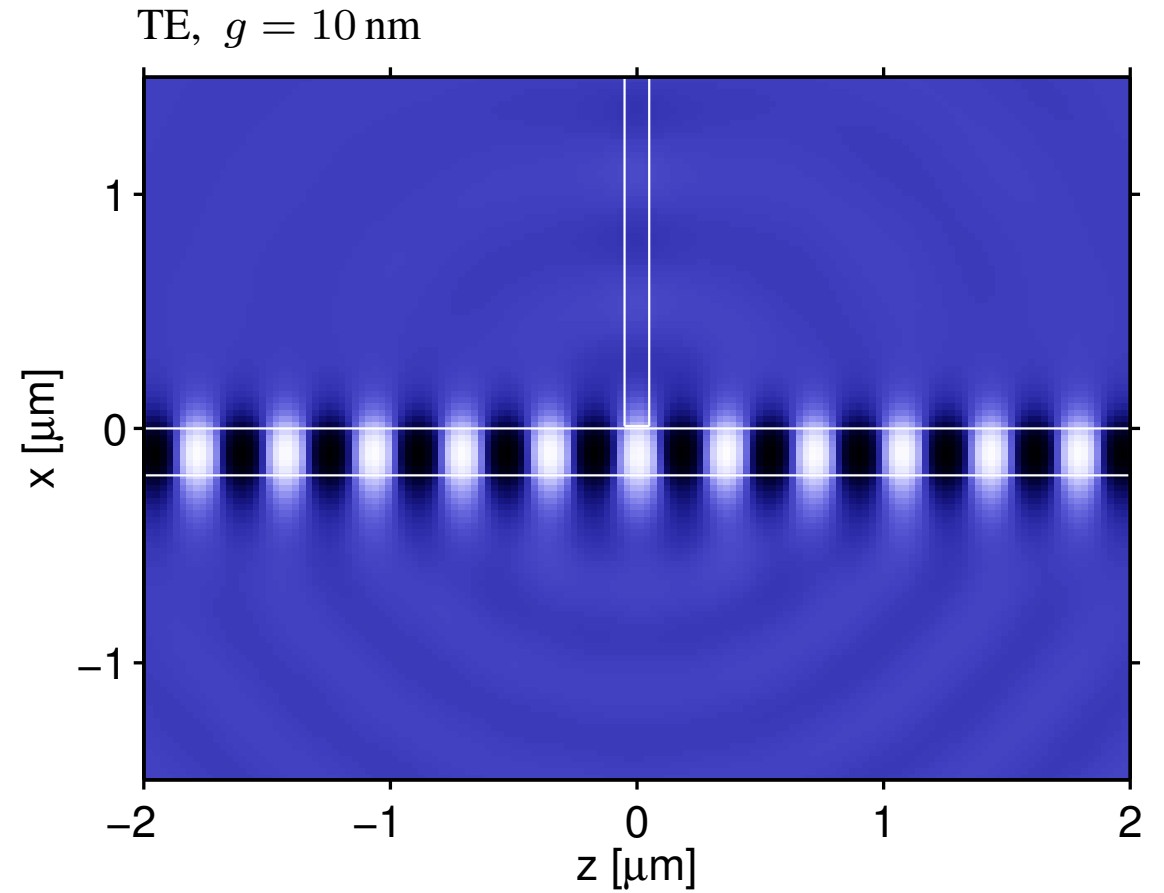
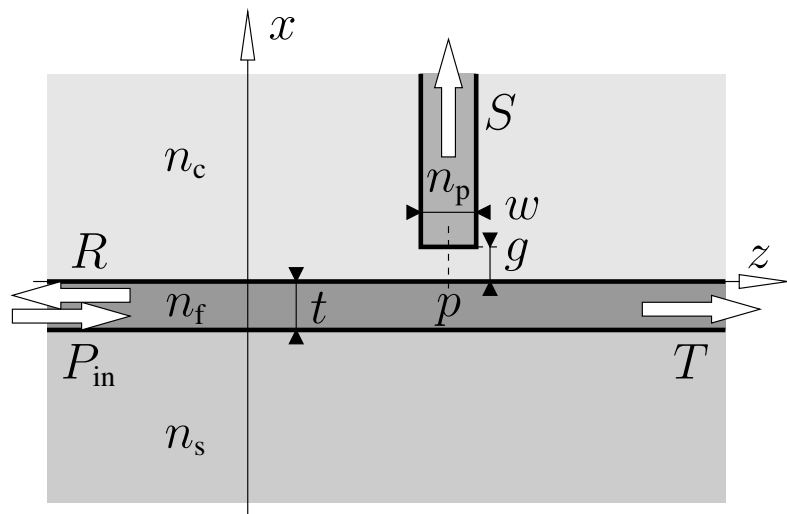
“QUadridirectional Eigenmode Propagation method” (QUEP).

Probing evanescent fields



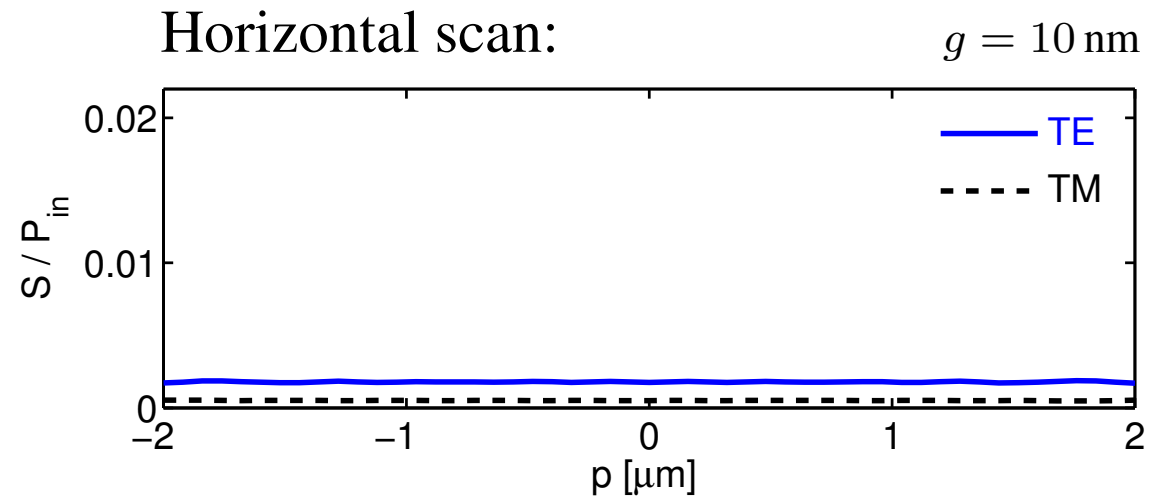
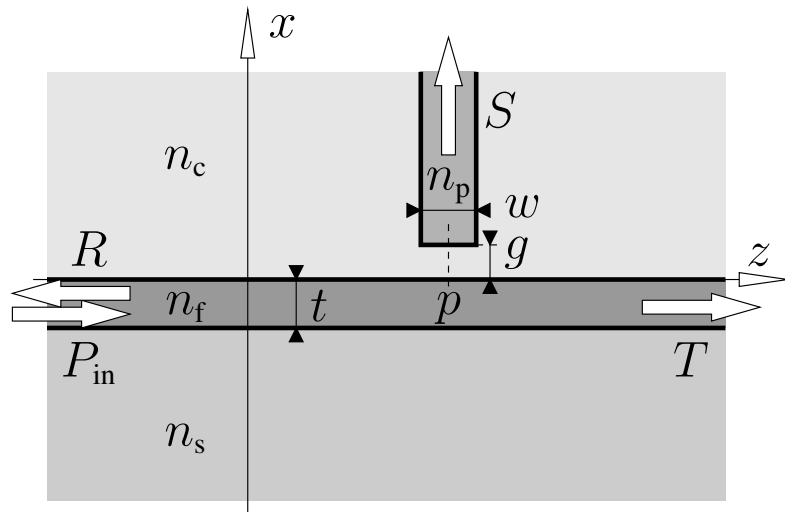
$n_s = 1.45$, $n_f = 2.0$, $n_c = 1.0$, $t = 0.2 \mu\text{m}$, $w = 100$ nm, $n_p = 1.5$,
 $\lambda = 0.633 \mu\text{m}$, $(x, z) \in [-3.0, 3.0] \times [-3.0, 3.0] \mu\text{m}^2$, $M_x = M_z = 80$.

Probing evanescent fields



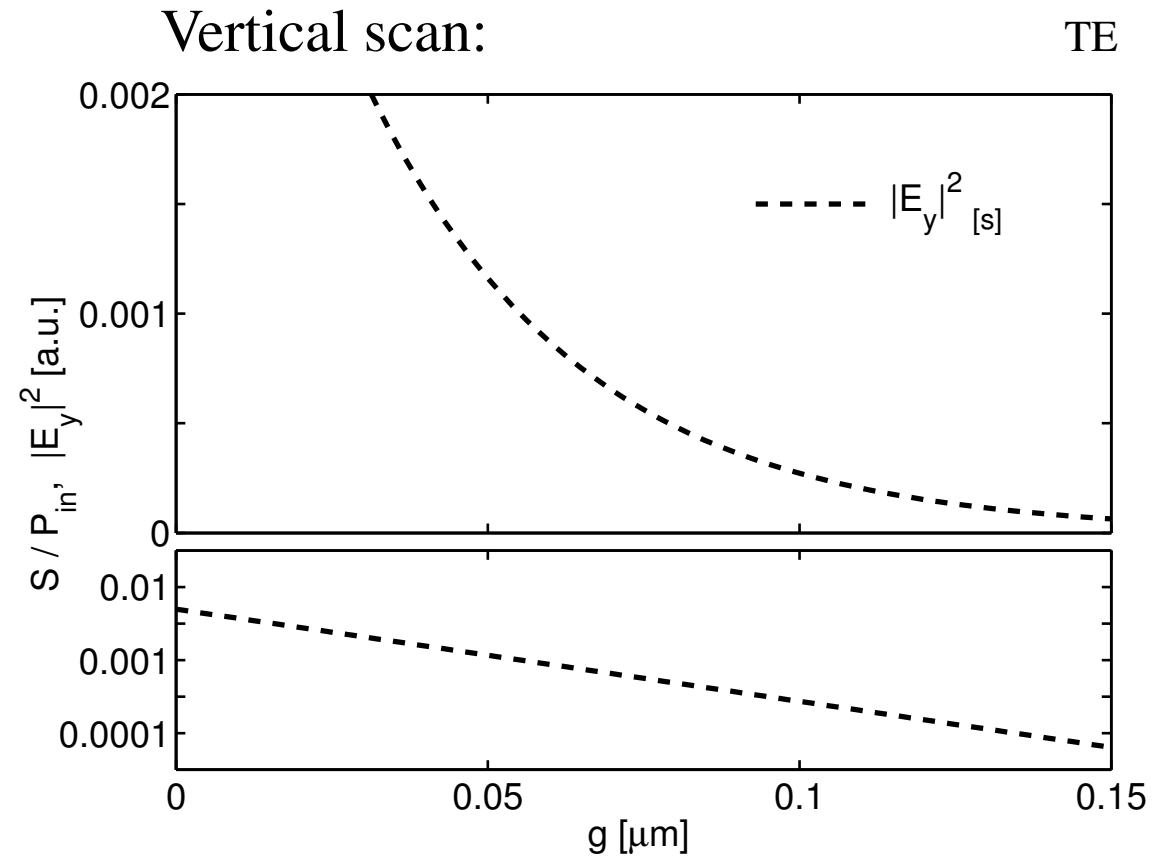
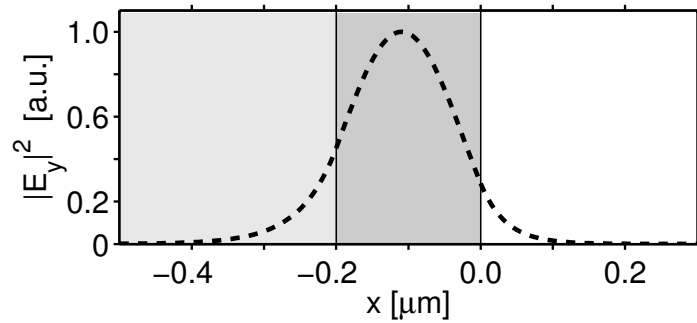
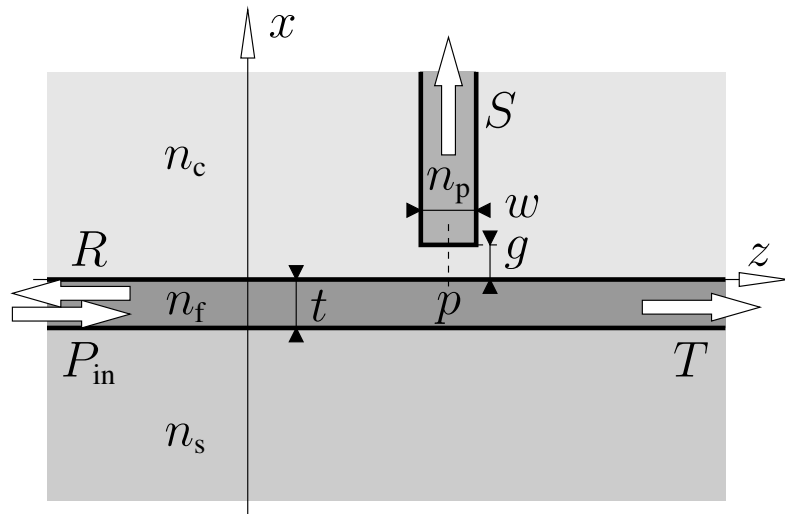
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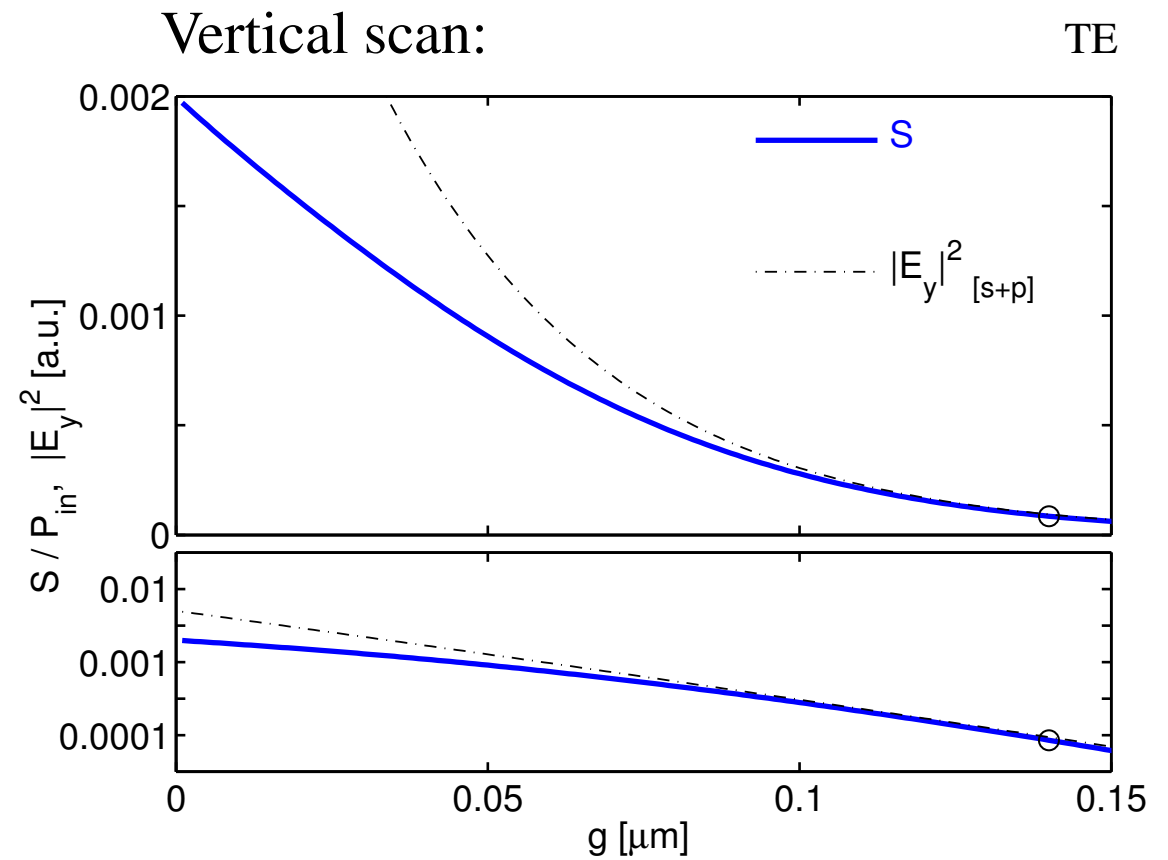
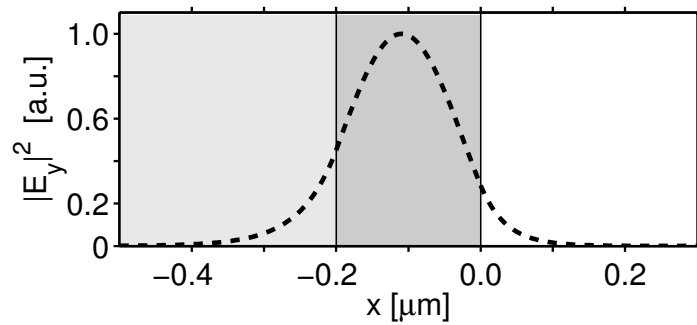
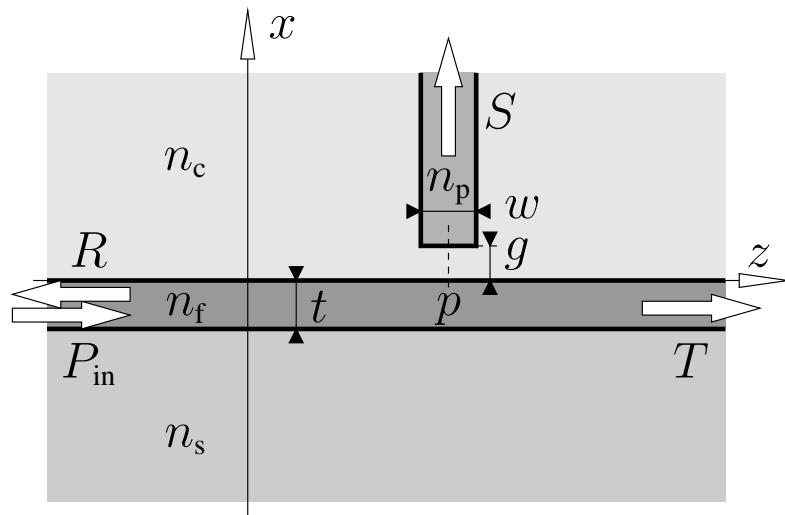


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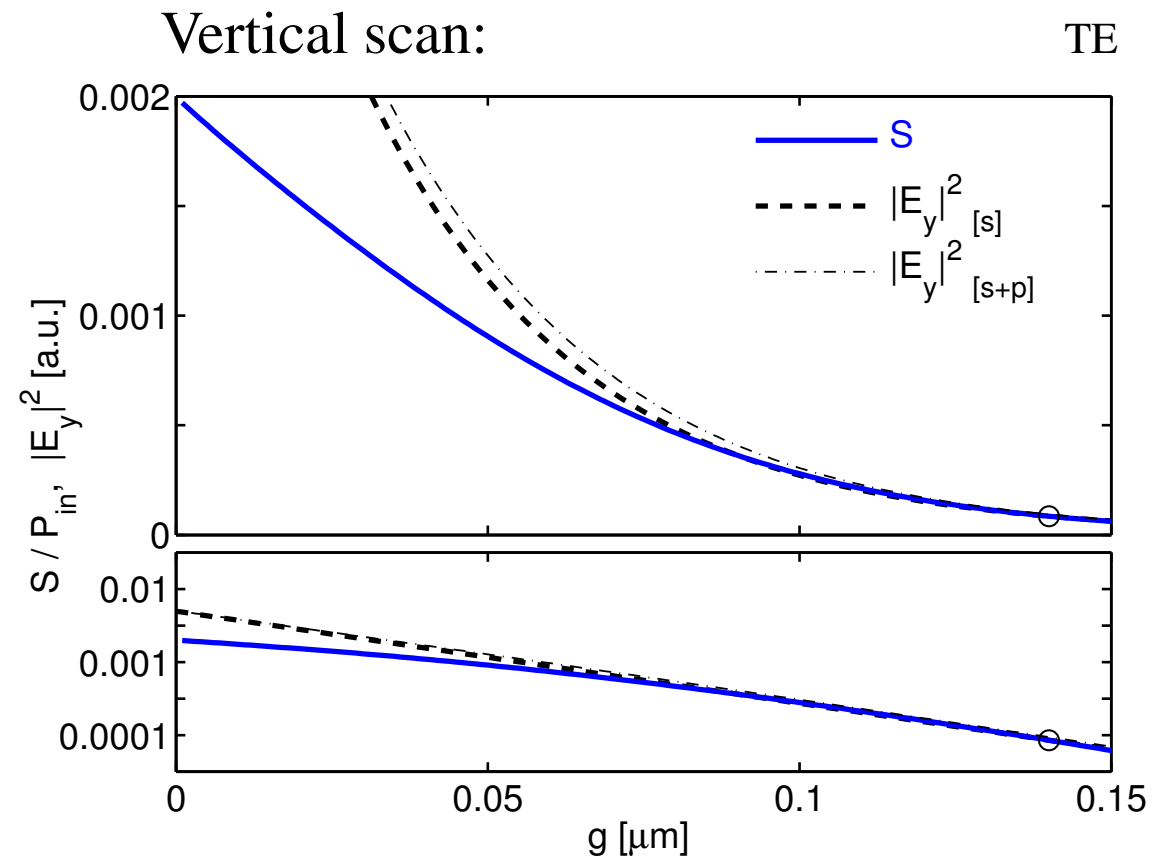
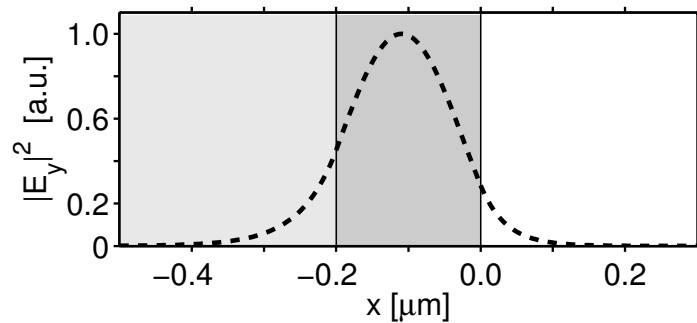
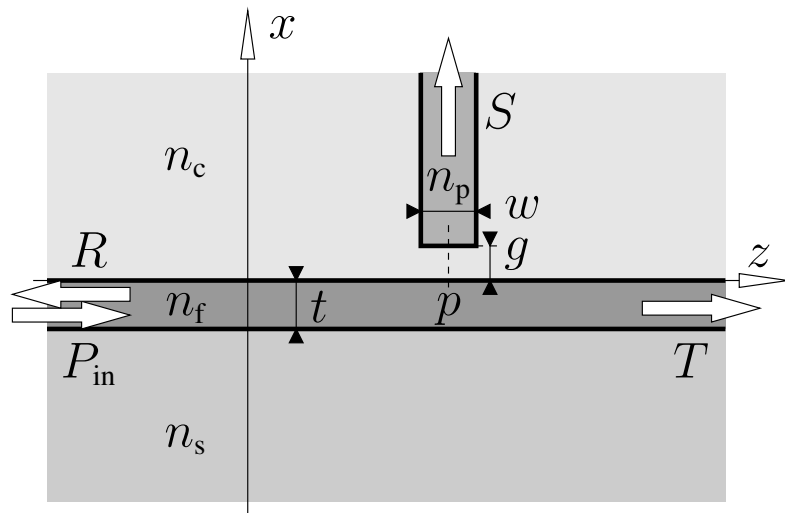
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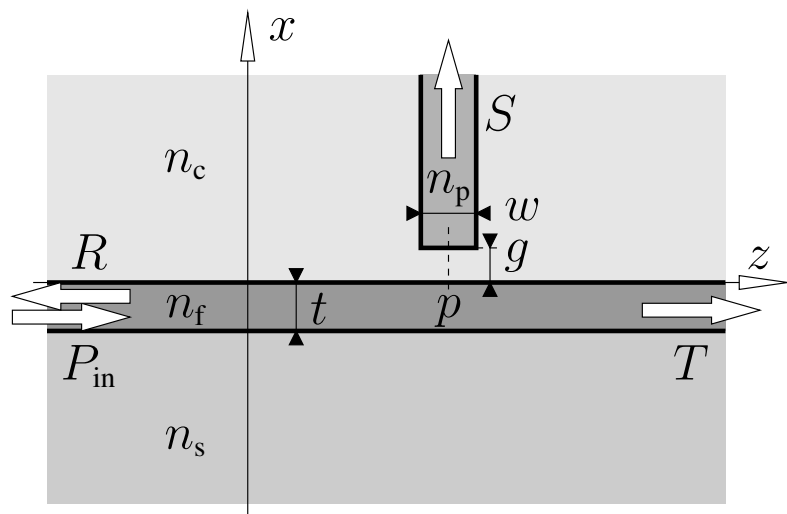
Probing evanescent fields



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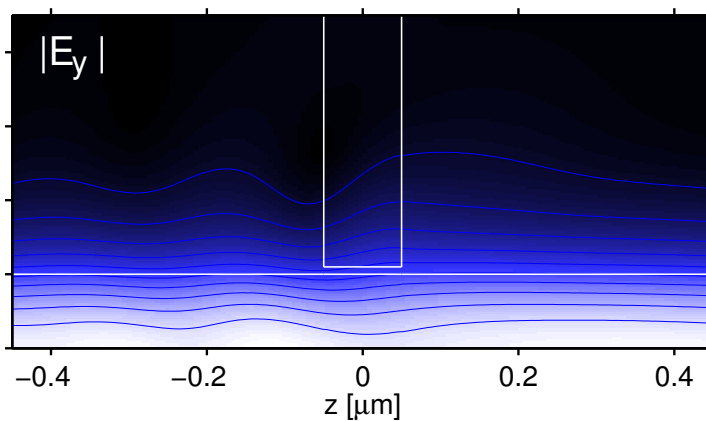
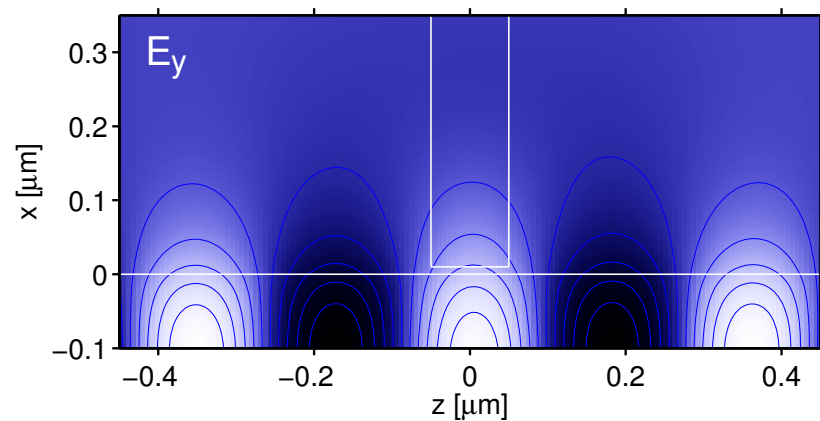
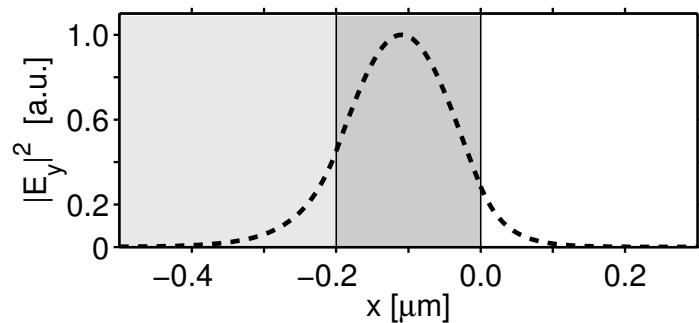
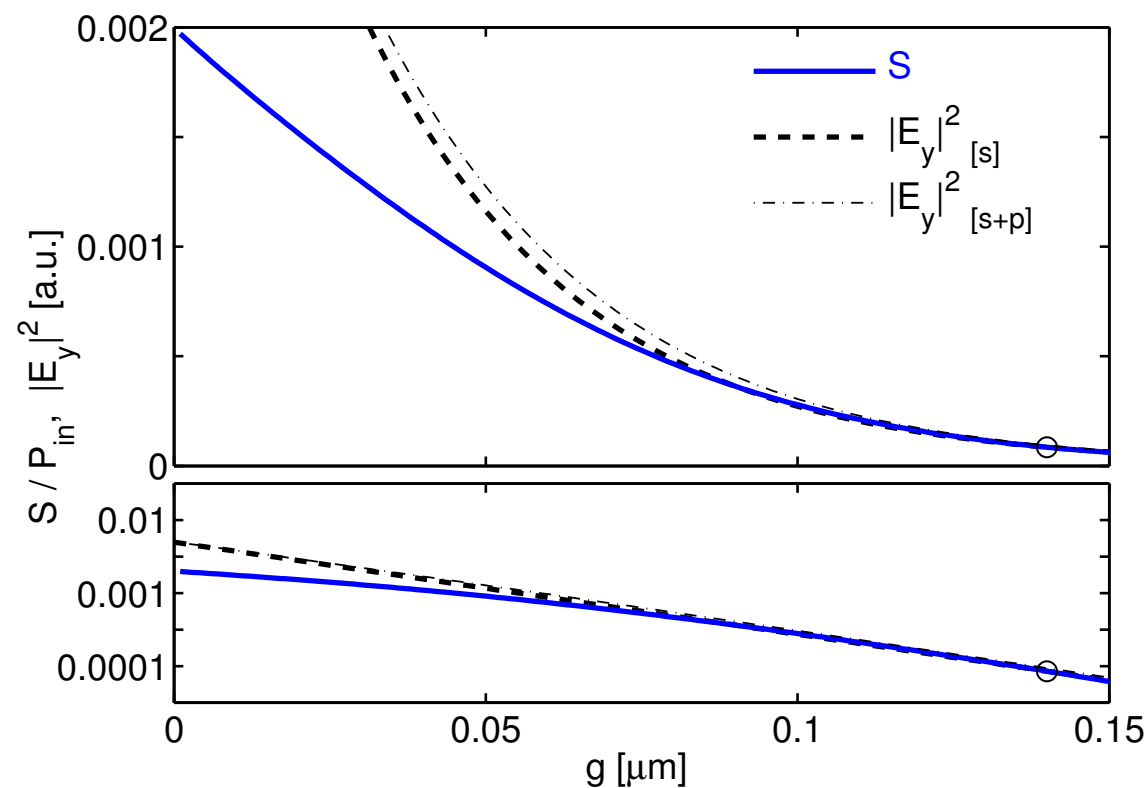


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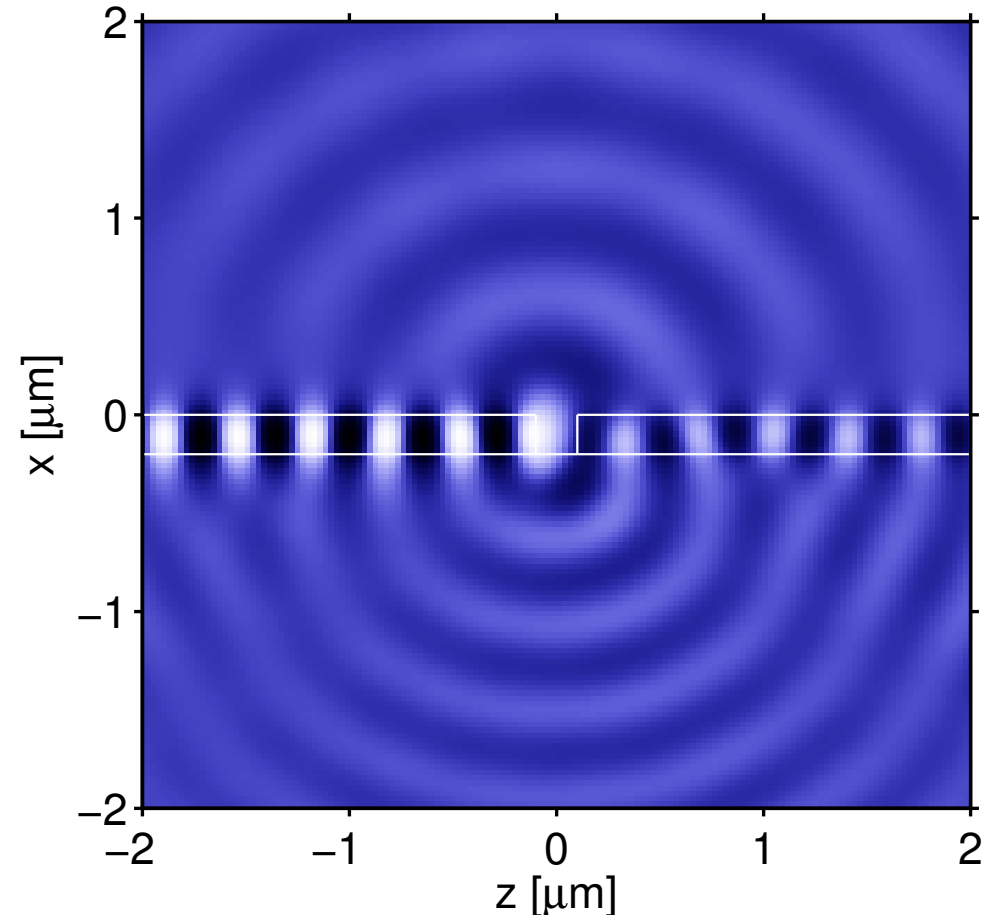
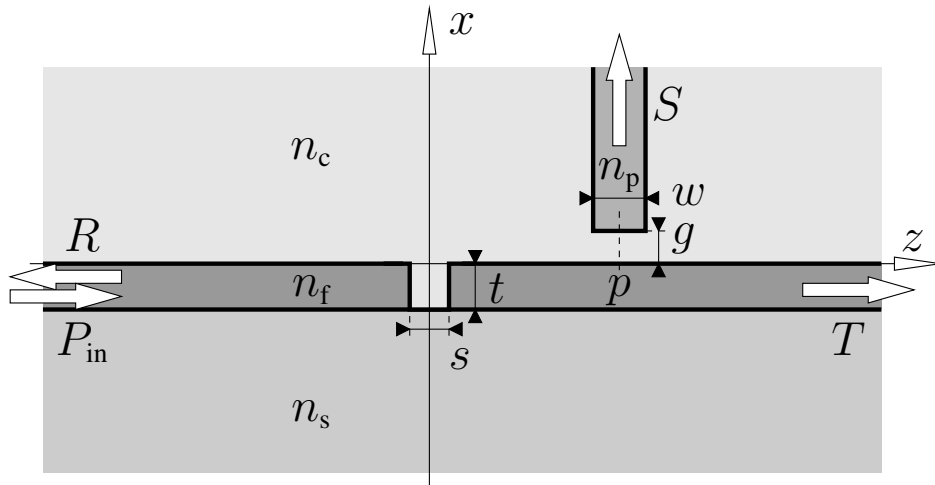


Vertical scan:

TE

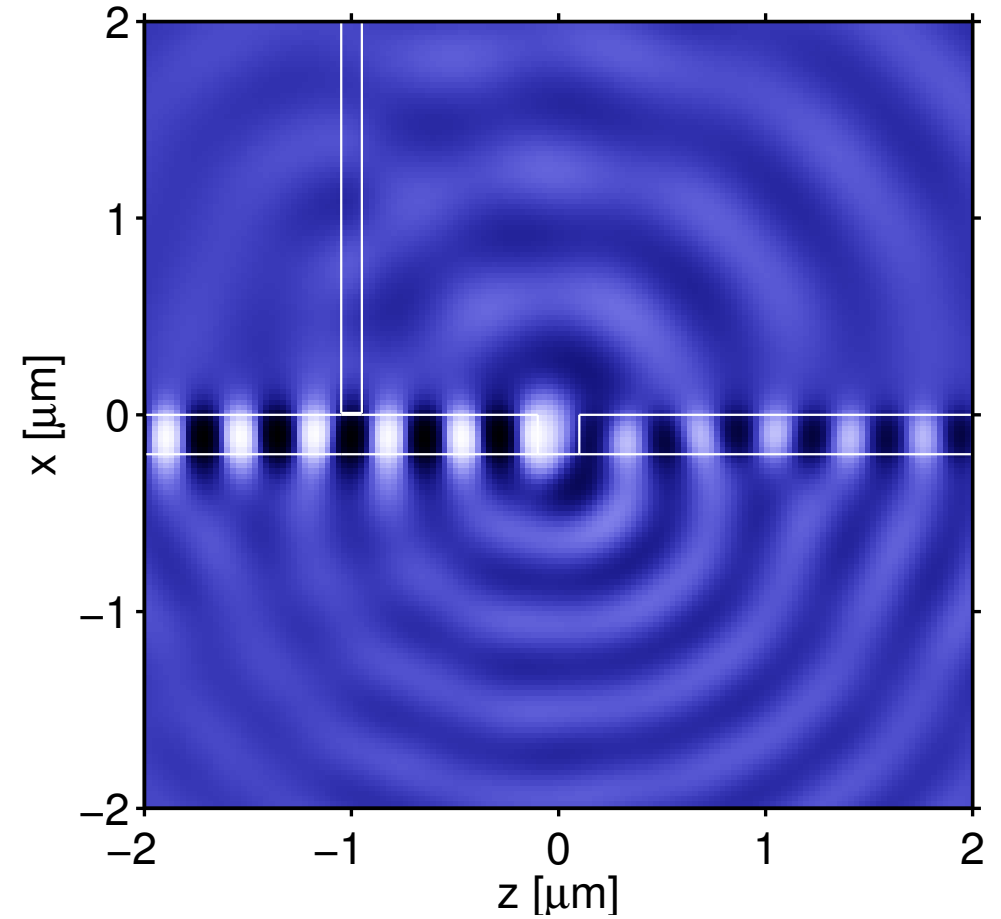
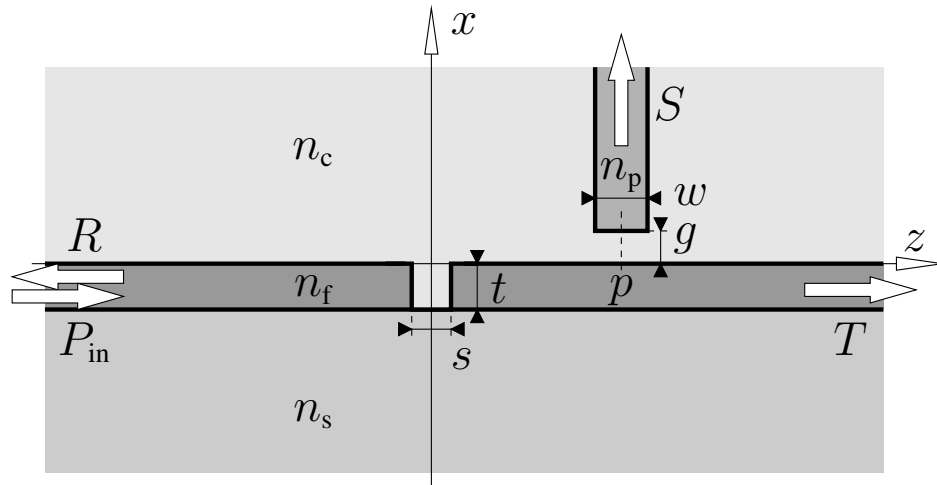


Hole defect in a slab waveguide



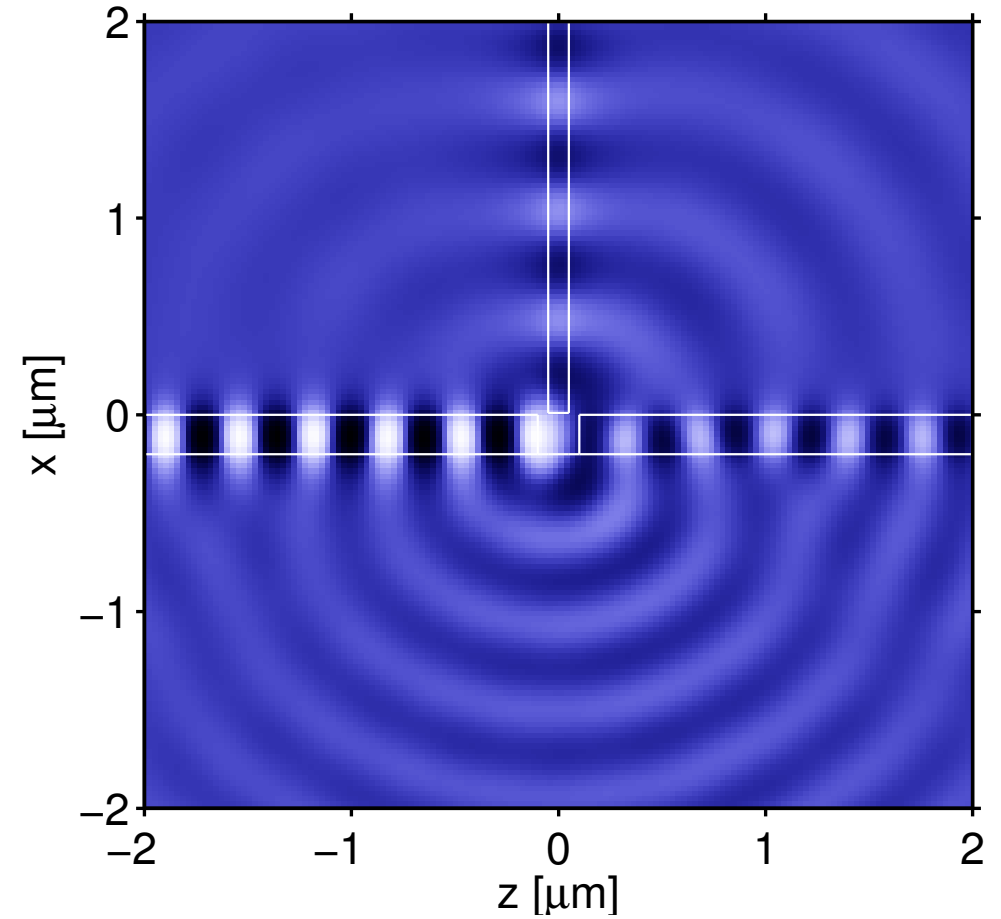
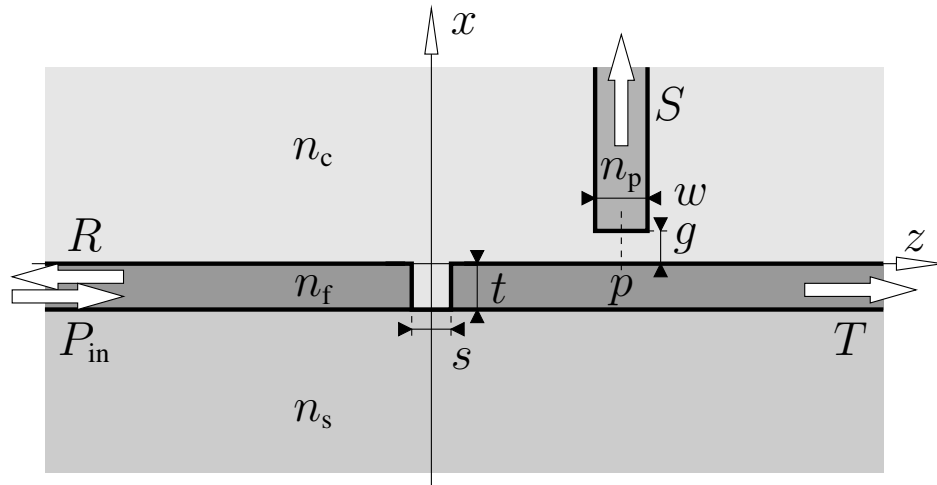
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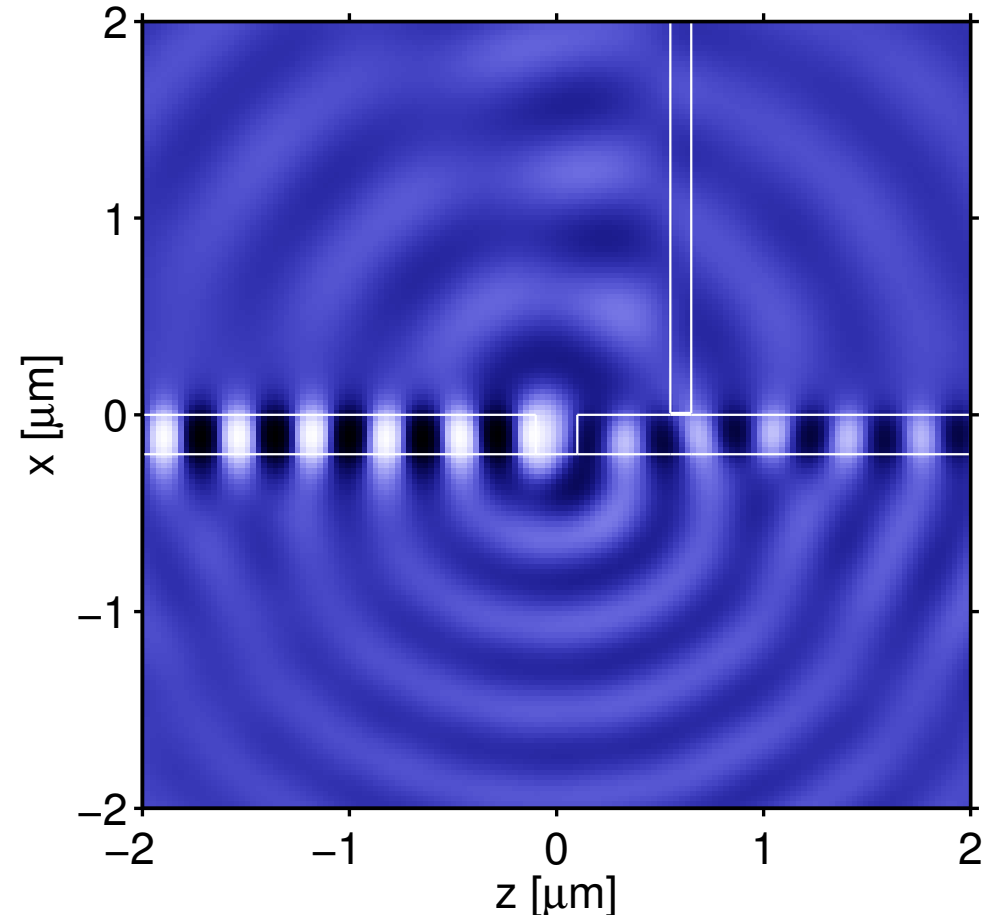
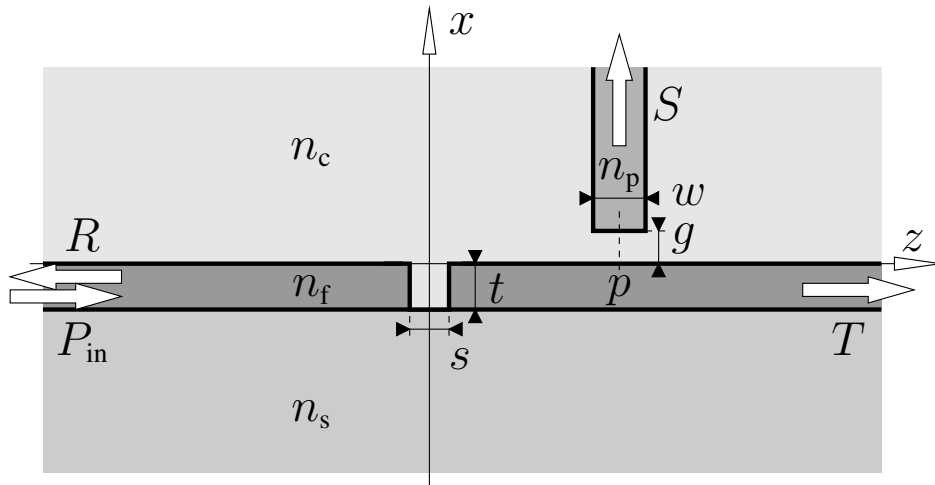
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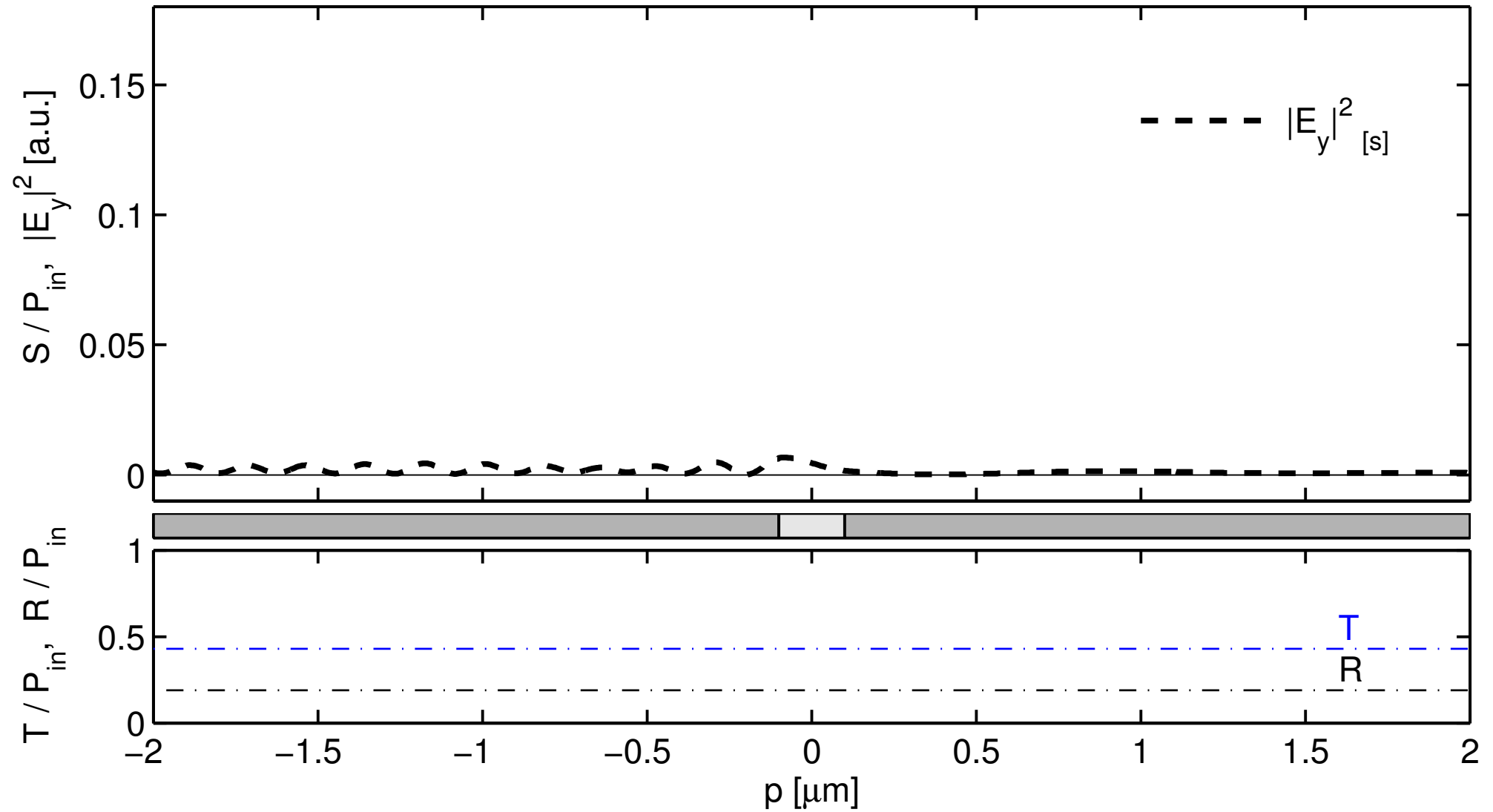
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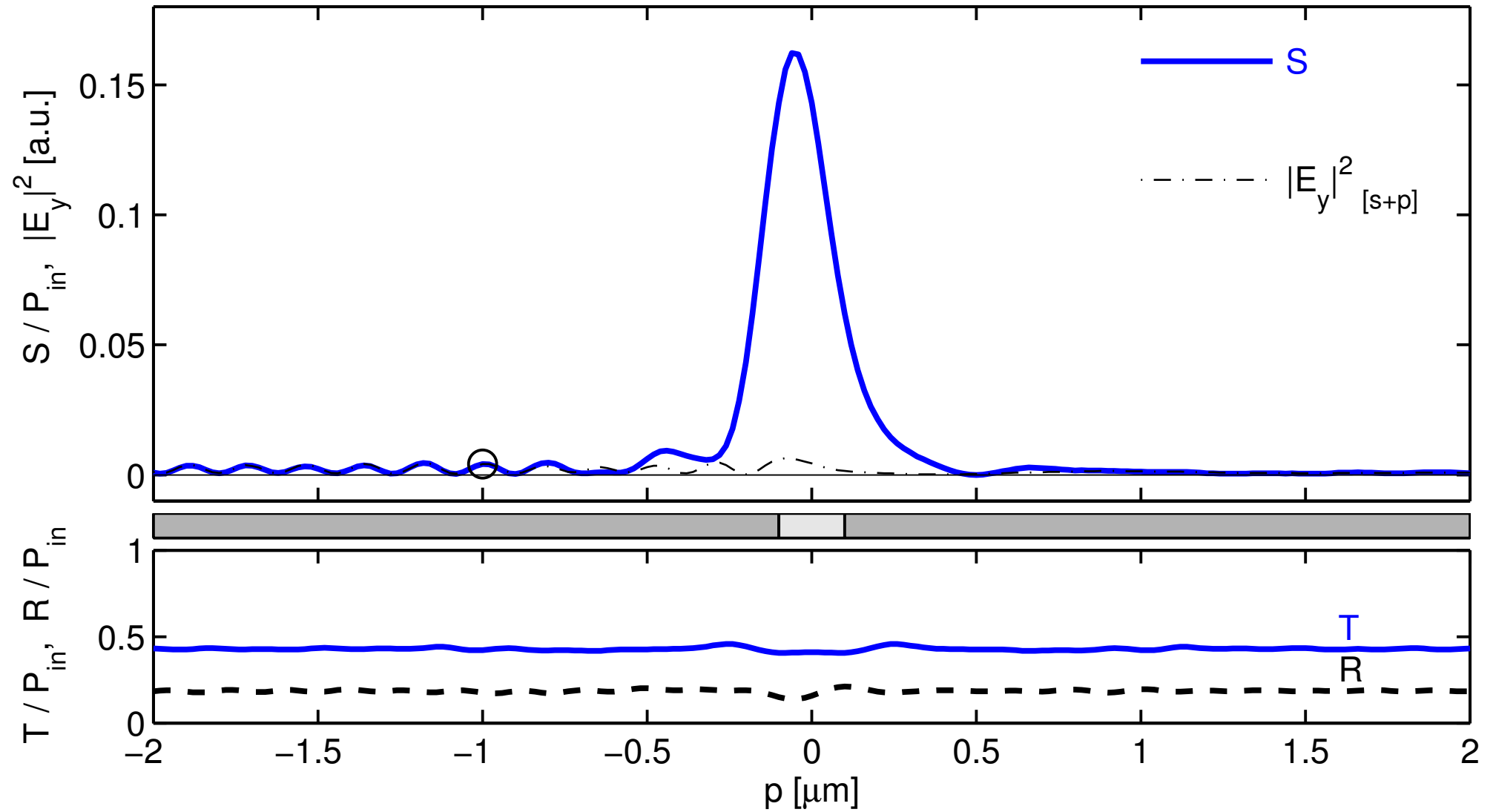


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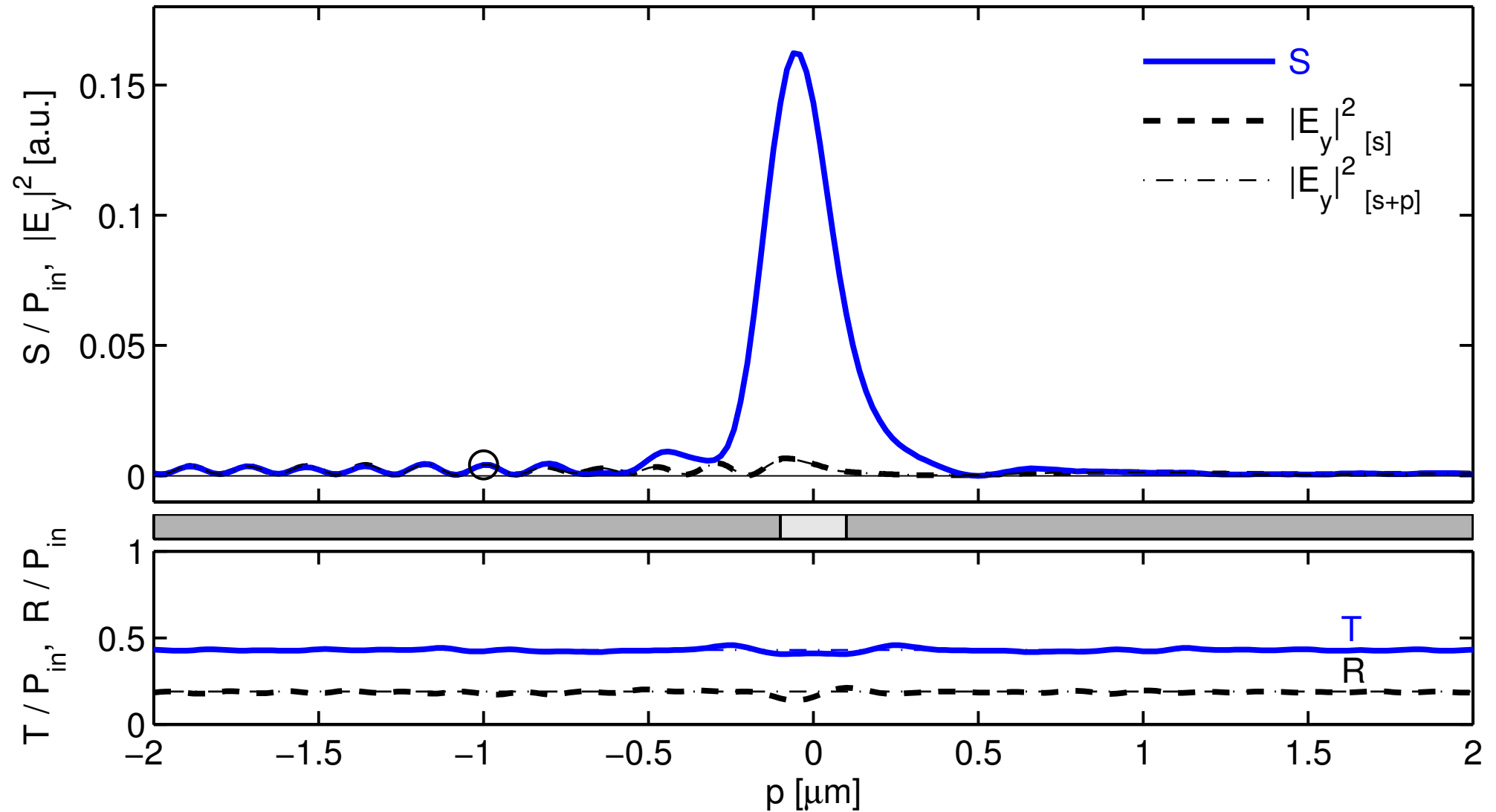
Hole defect in a slab waveguide



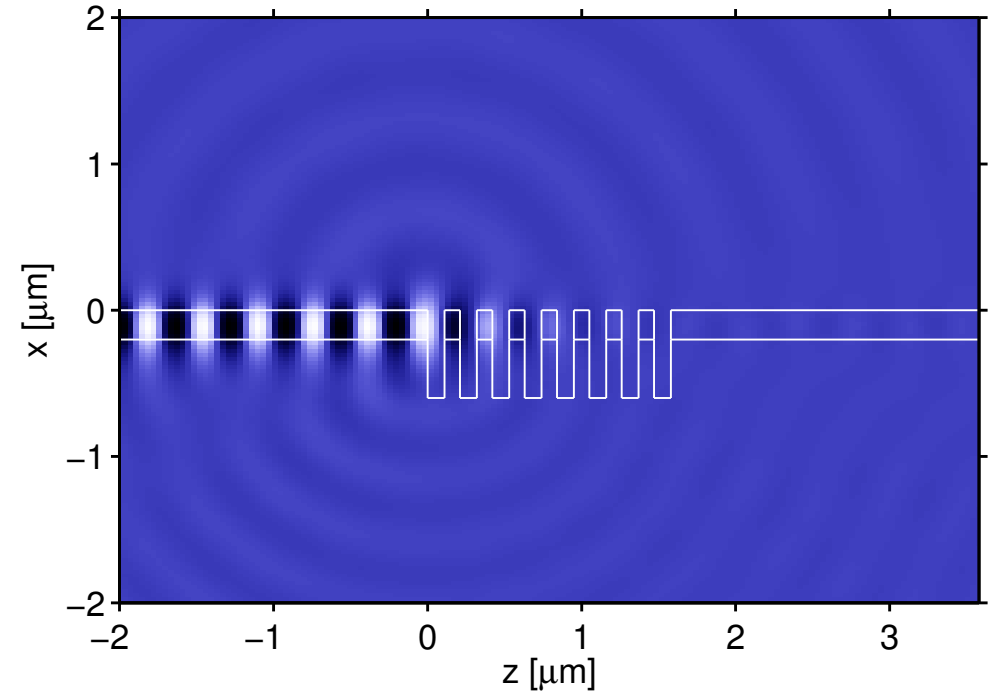
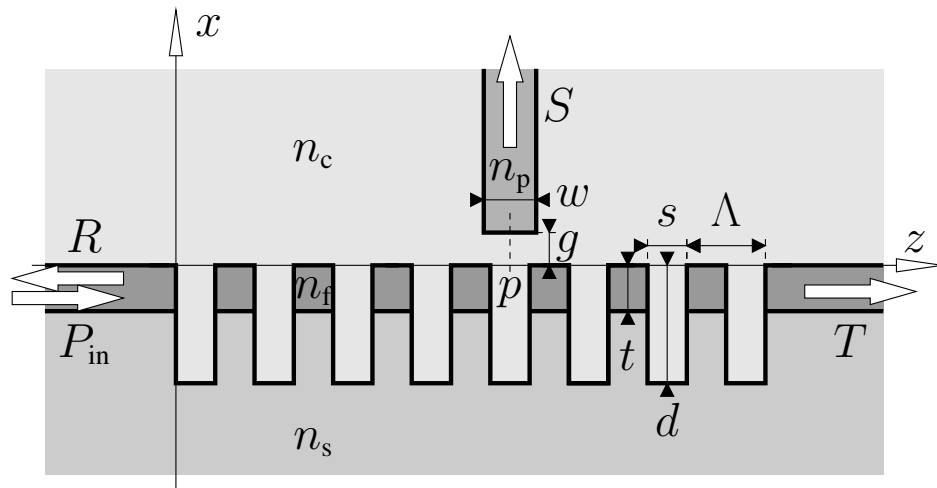
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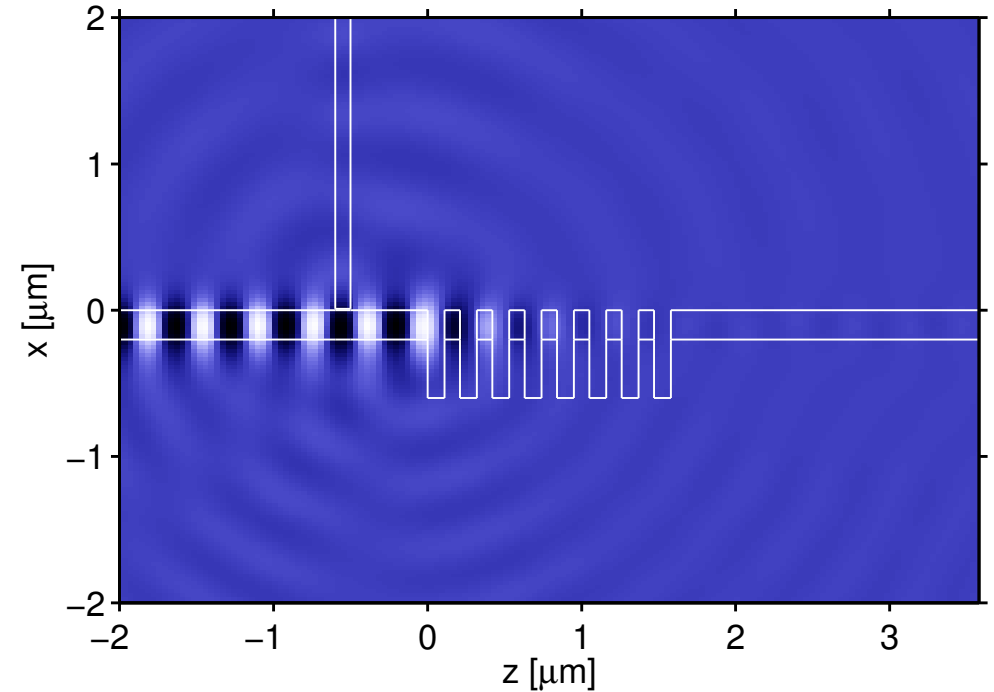
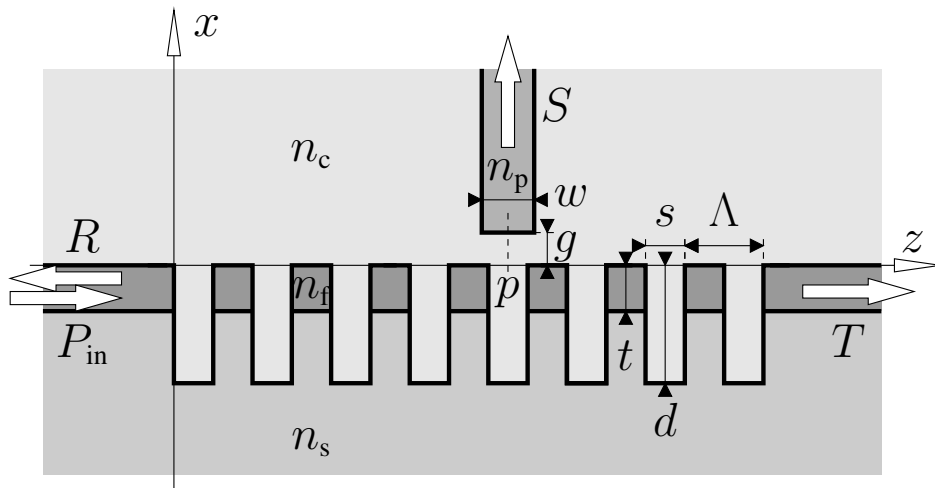


Short waveguide Bragg grating



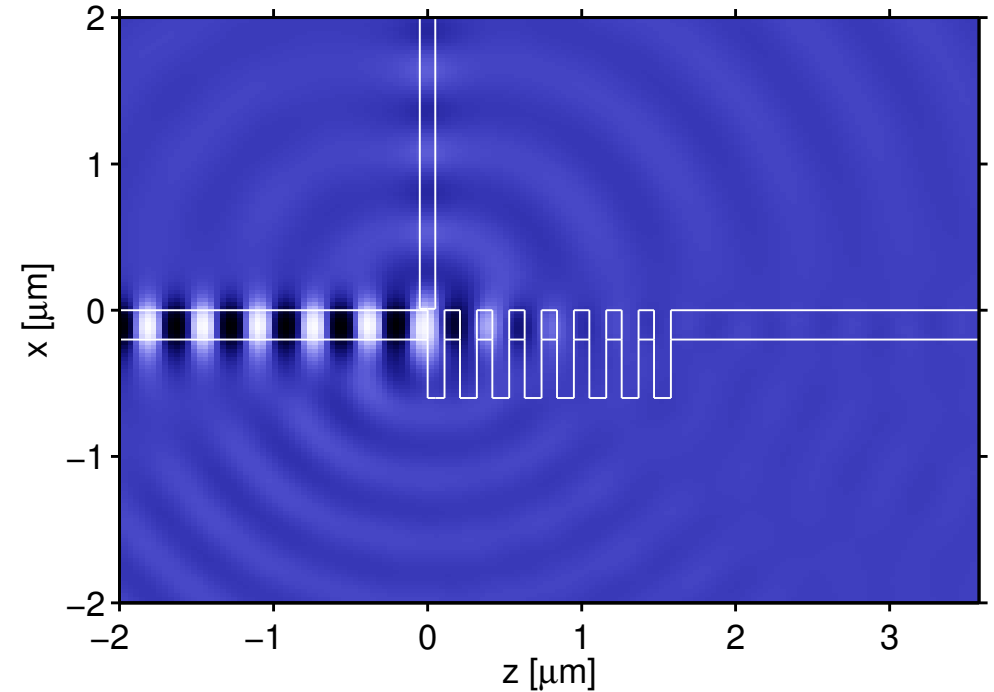
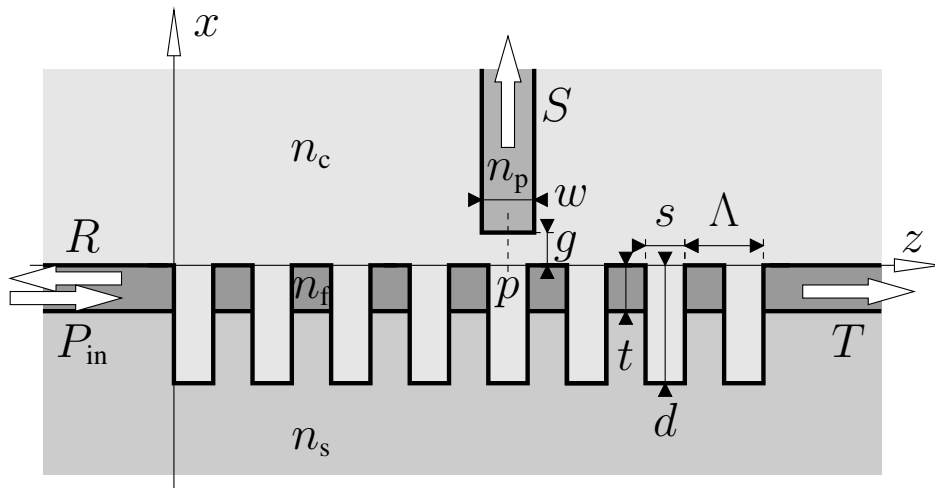
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 $\Lambda = 0.21 \mu\text{m}$, $s = 0.11 \mu\text{m}$, $g = 10 \text{ nm}$, $w = 100 \text{ nm}$, $n_p = 1.5$,
 TE, $\lambda = 0.633 \mu\text{m}$, $(x, z) \in [-3.0, 3.0] \times [-3.0, 4.58] \mu\text{m}^2$, $M_x = 100$, $M_z = 120$.

Short waveguide Bragg grating



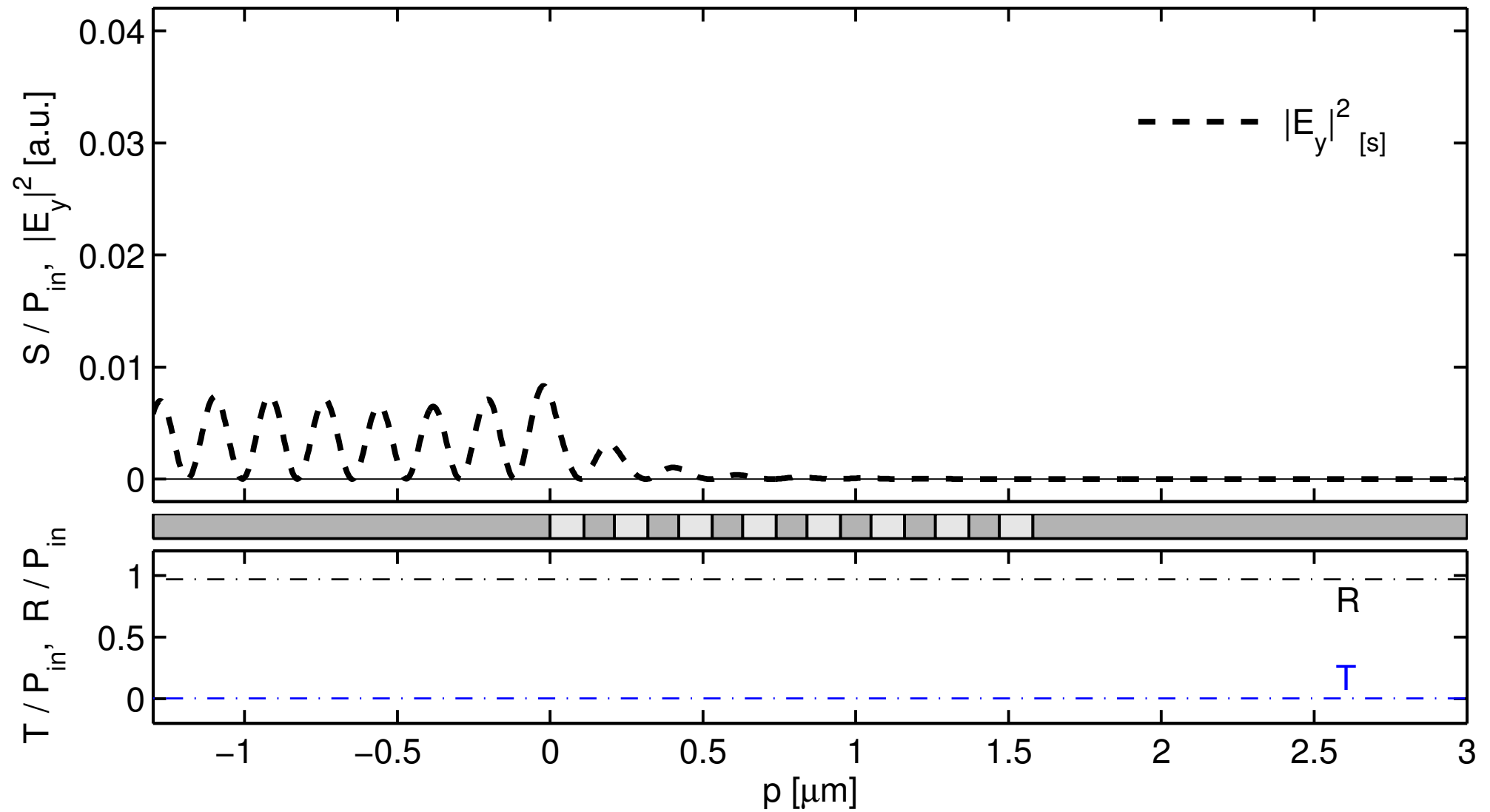
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Short waveguide Bragg grating

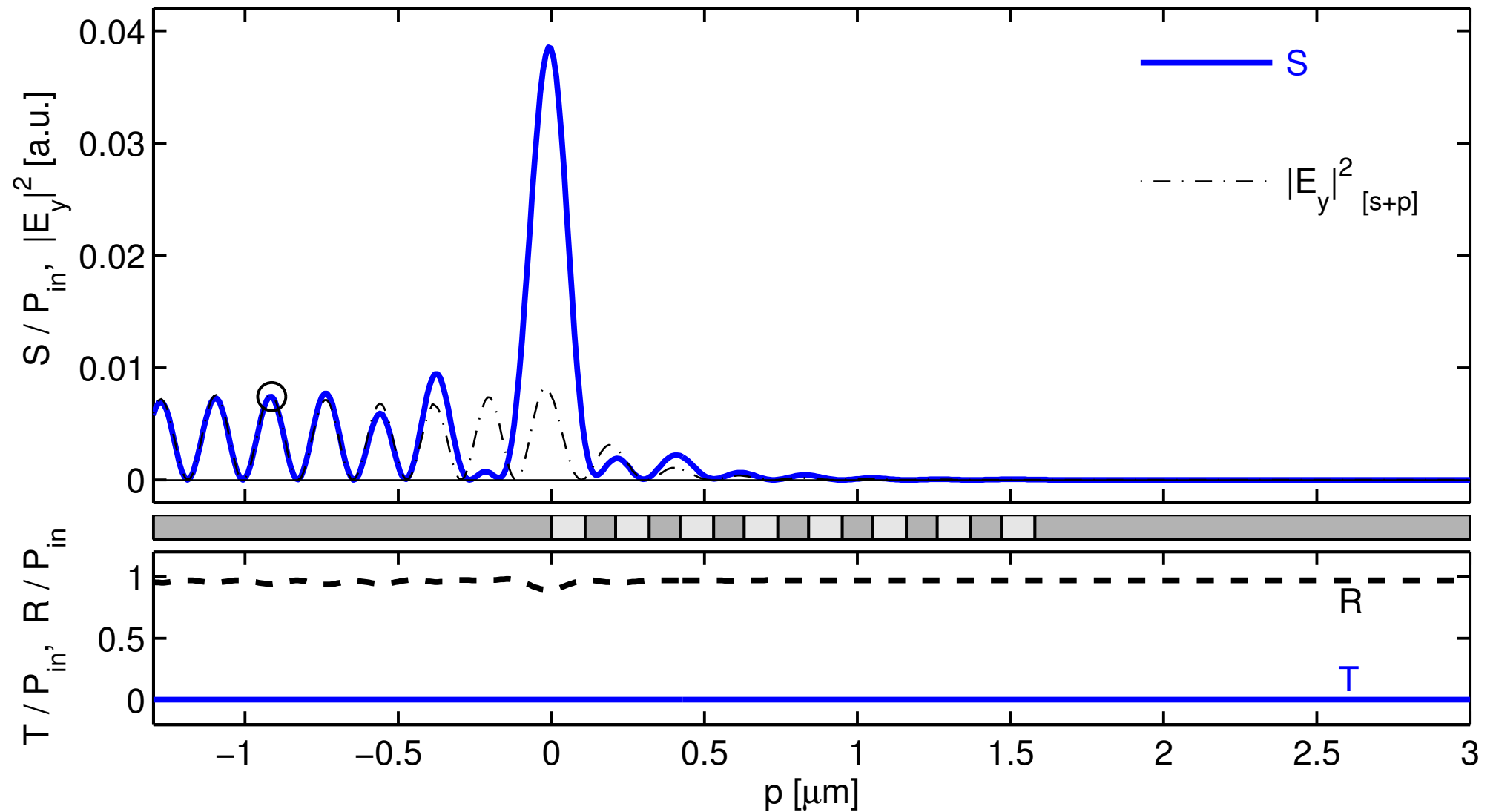


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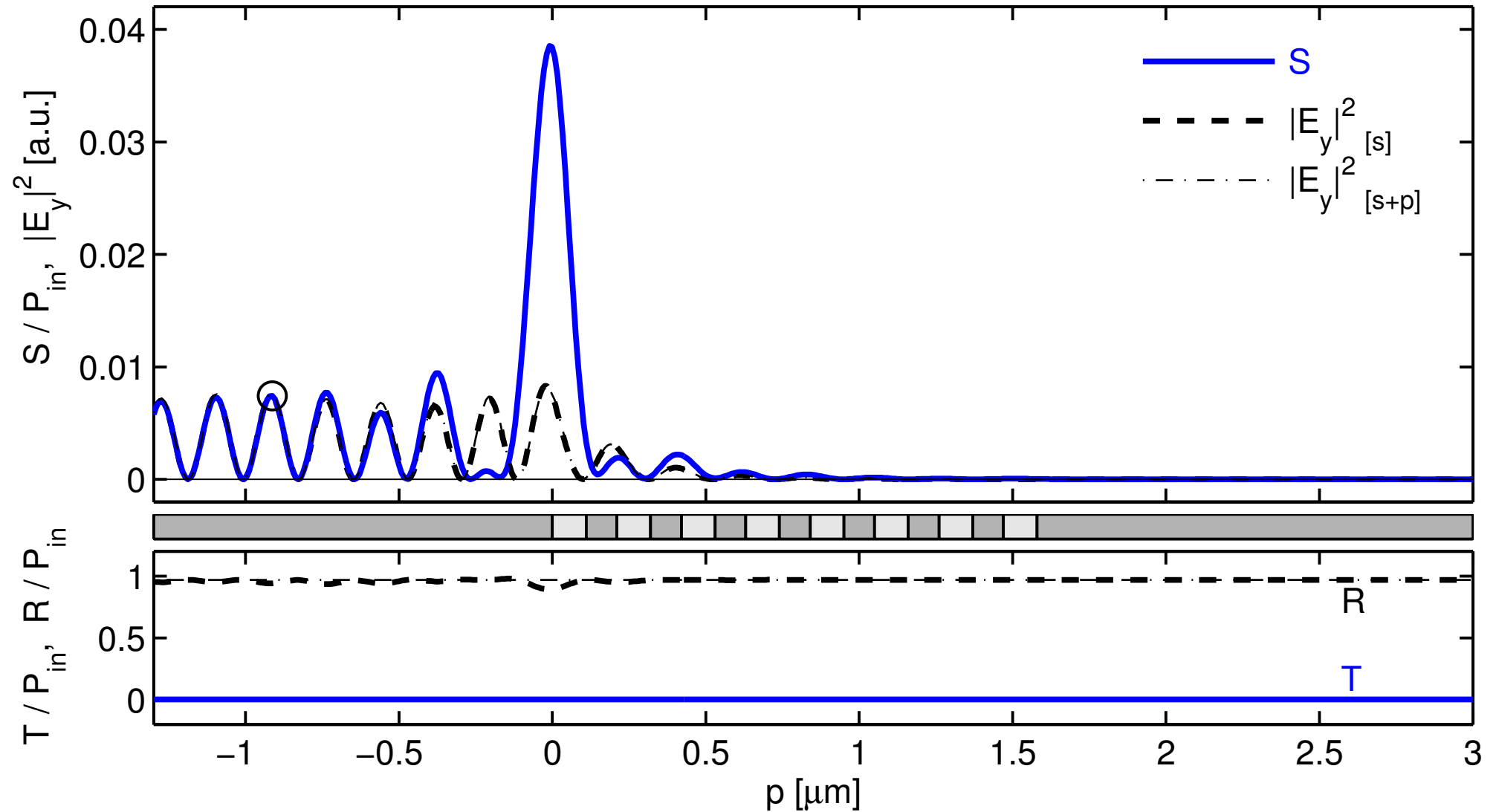
Short waveguide Bragg grating



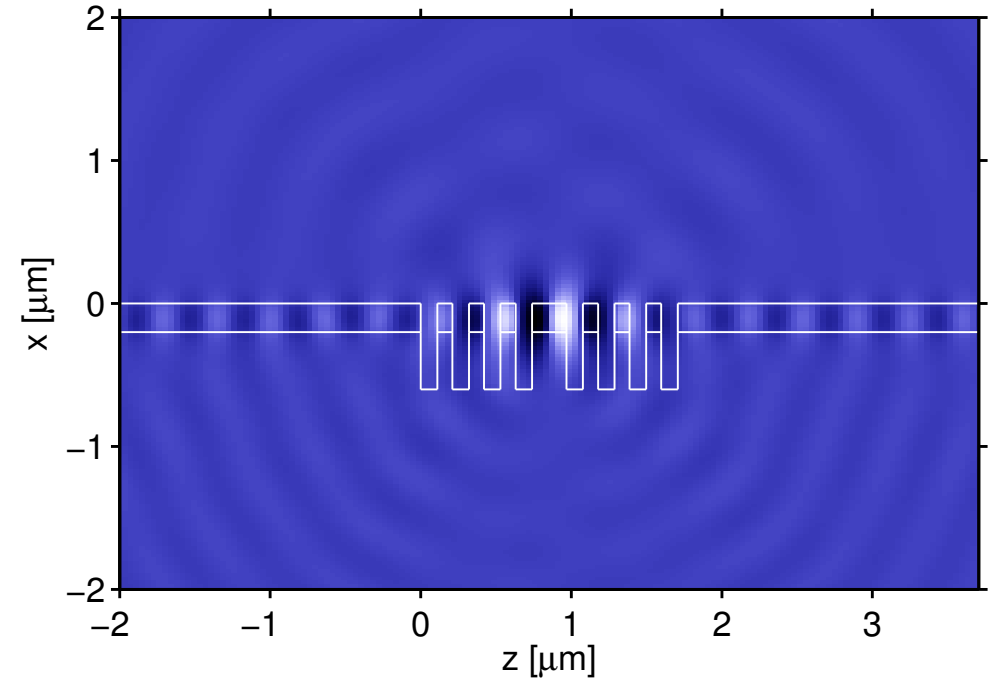
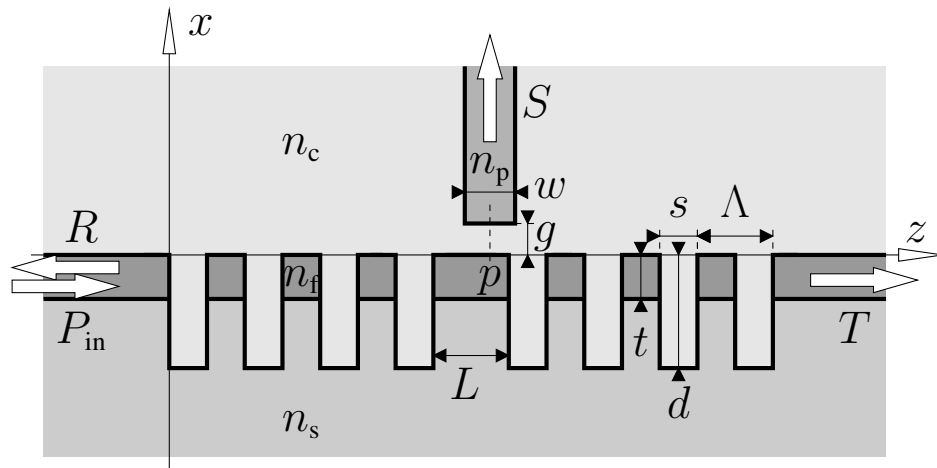
Short waveguide Bragg grating



Short waveguide Bragg grating

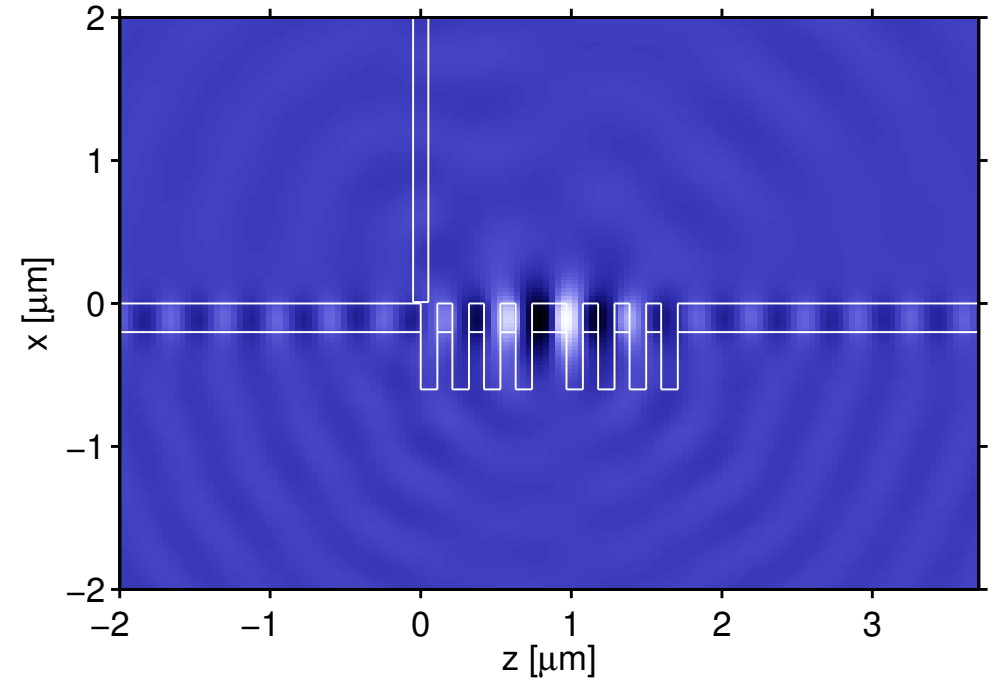
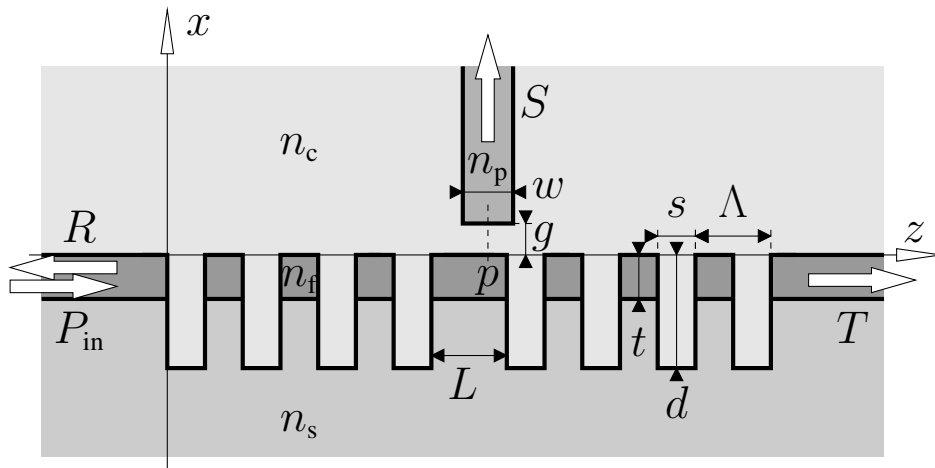


Resonant defect cavity



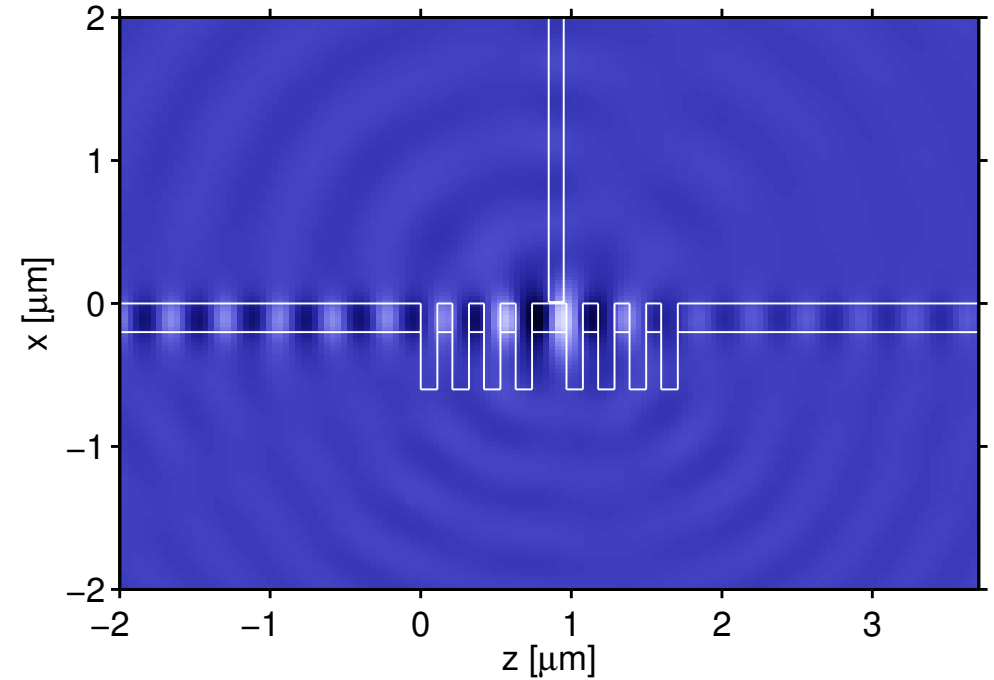
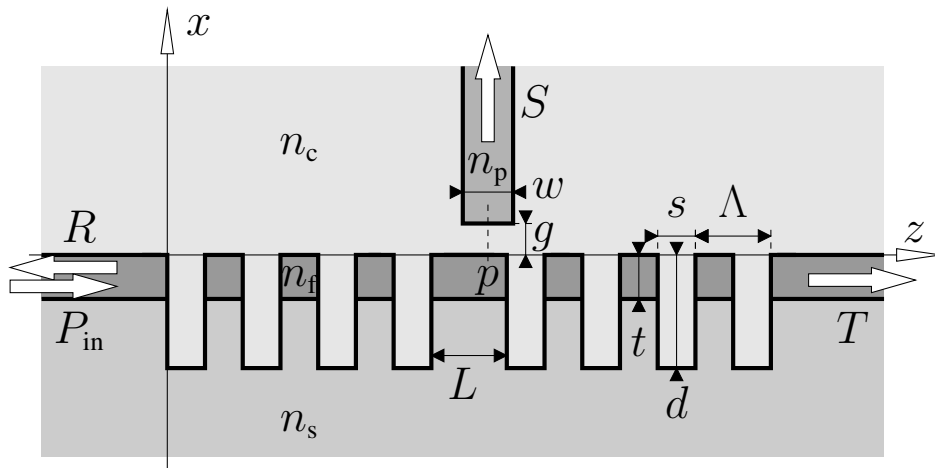
$n_s = 1.45, n_f = 2.0, n_c = 1.0, t = 0.2 \mu\text{m}, d = 0.6 \mu\text{m},$
 $\Lambda = 0.21 \mu\text{m}, s = 0.11 \mu\text{m}, L = 0.2275 \mu\text{m}, g = 10 \text{ nm}, w = 100 \text{ nm}, n_p = 1.5,$
 $\text{TE}, \lambda = 0.633 \mu\text{m}, (x, z) \in [-3.0, 3.0] \times [-3.0, 4.7075] \mu\text{m}^2, M_x = 100, M_z = 120.$

Resonant defect cavity



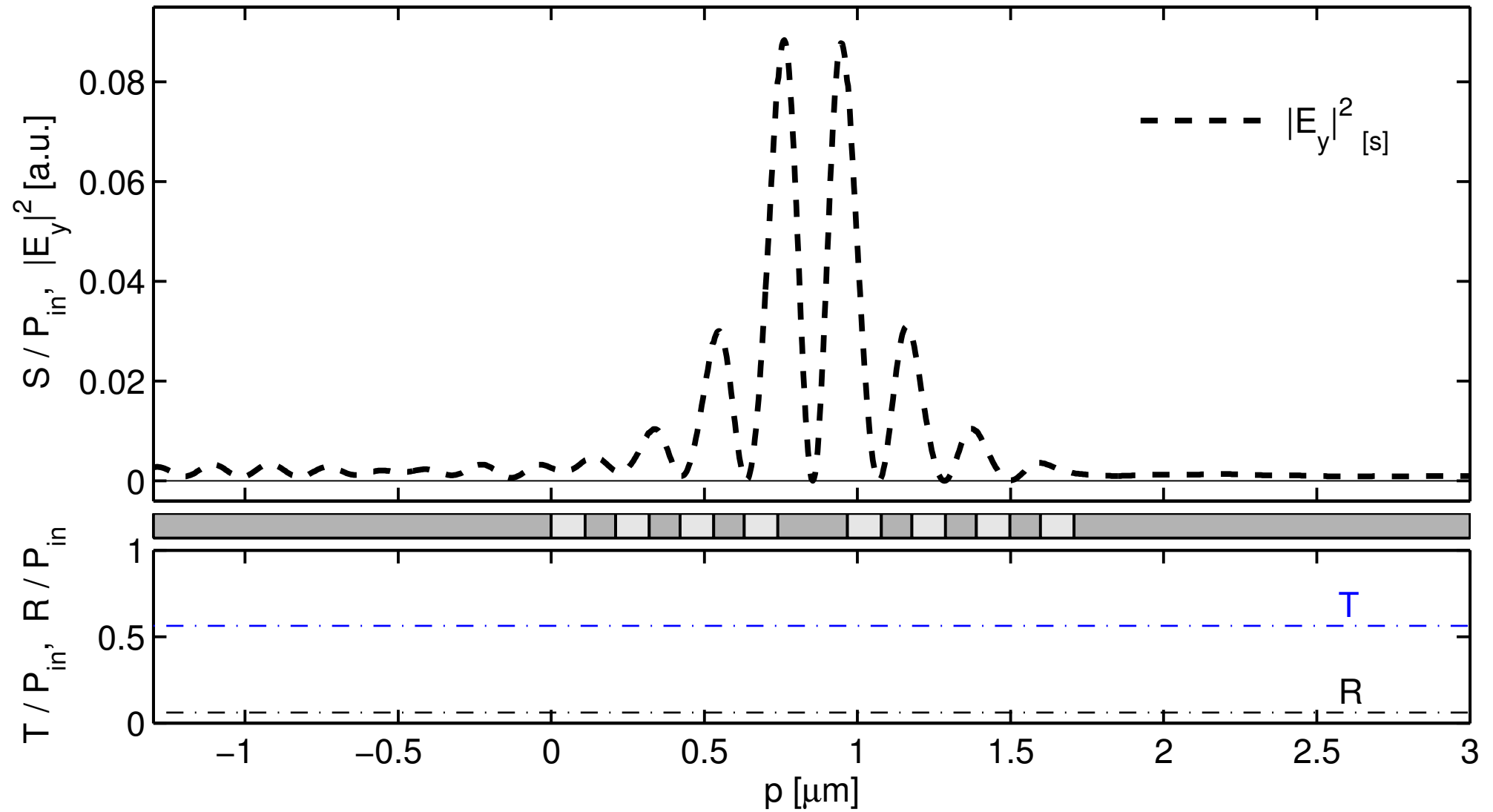
$n_s = 1.45, n_f = 2.0, n_c = 1.0, t = 0.2 \mu\text{m}, d = 0.6 \mu\text{m},$
 $\Lambda = 0.21 \mu\text{m}, s = 0.11 \mu\text{m}, L = 0.2275 \mu\text{m}, g = 10 \text{ nm}, w = 100 \text{ nm}, n_p = 1.5,$
 $\text{TE}, \lambda = 0.633 \mu\text{m}, (x, z) \in [-3.0, 3.0] \times [-3.0, 4.7075] \mu\text{m}^2, M_x = 100, M_z = 120.$

Resonant defect cavity

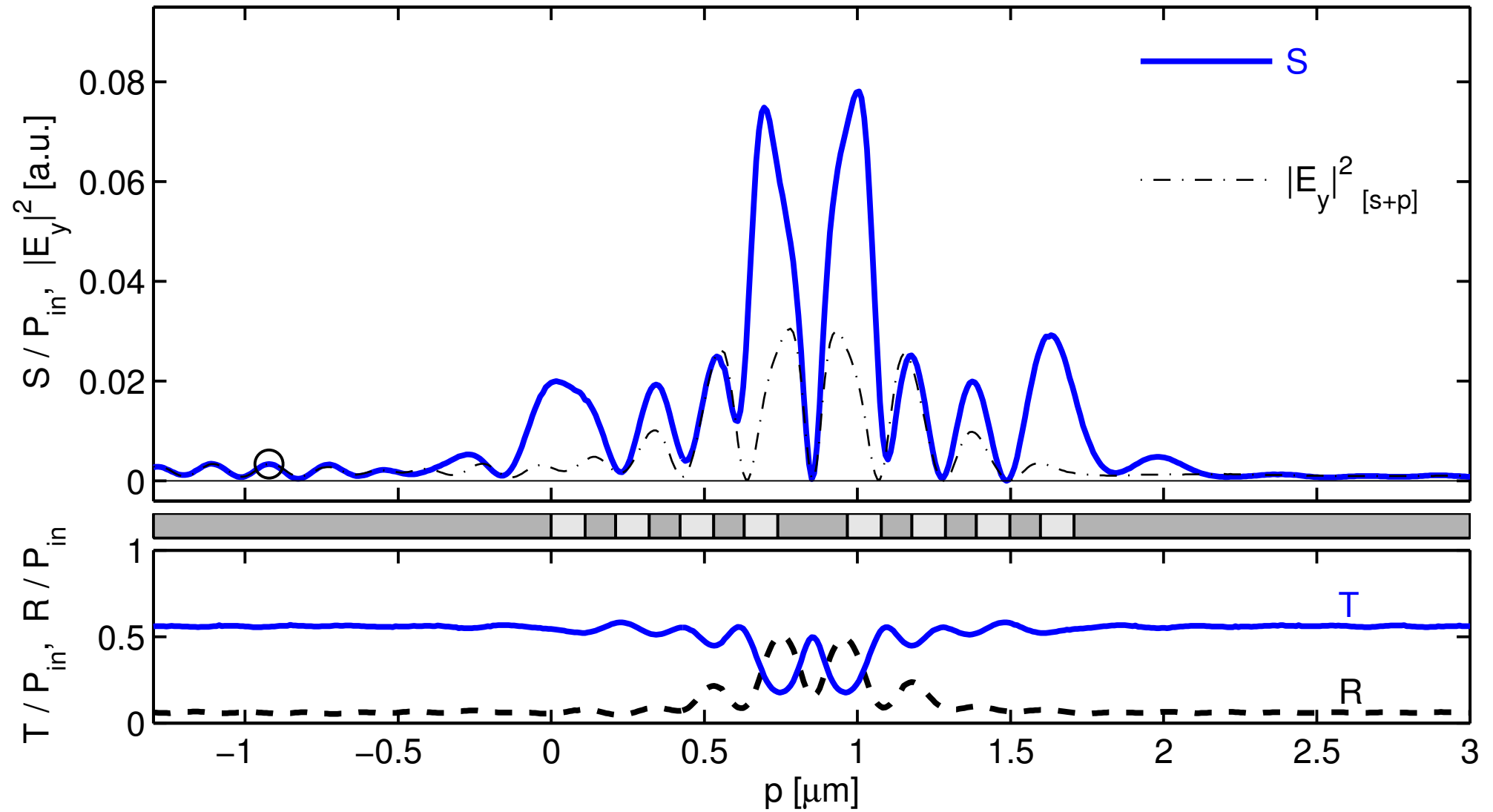


$n_s = 1.45$, $n_f = 2.0$, $n_c = 1.0$, $t = 0.2 \mu\text{m}$, $d = 0.6 \mu\text{m}$,
 $\Lambda = 0.21 \mu\text{m}$, $s = 0.11 \mu\text{m}$, $L = 0.2275 \mu\text{m}$, $g = 10 \text{ nm}$, $w = 100 \text{ nm}$, $n_p = 1.5$,
 TE, $\lambda = 0.633 \mu\text{m}$, $(x, z) \in [-3.0, 3.0] \times [-3.0, 4.7075] \mu\text{m}^2$, $M_x = 100$, $M_z = 120$.

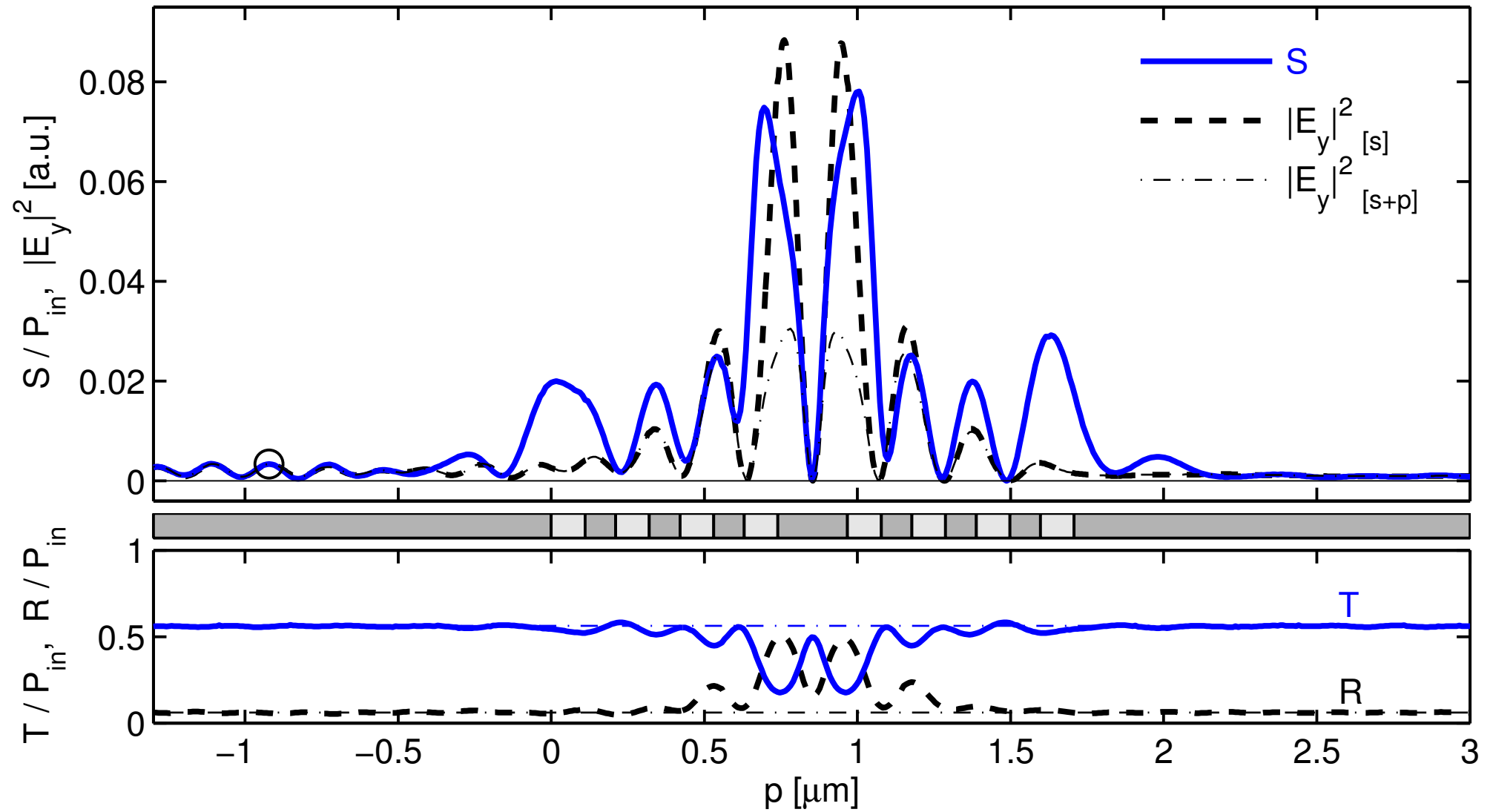
Resonant defect cavity

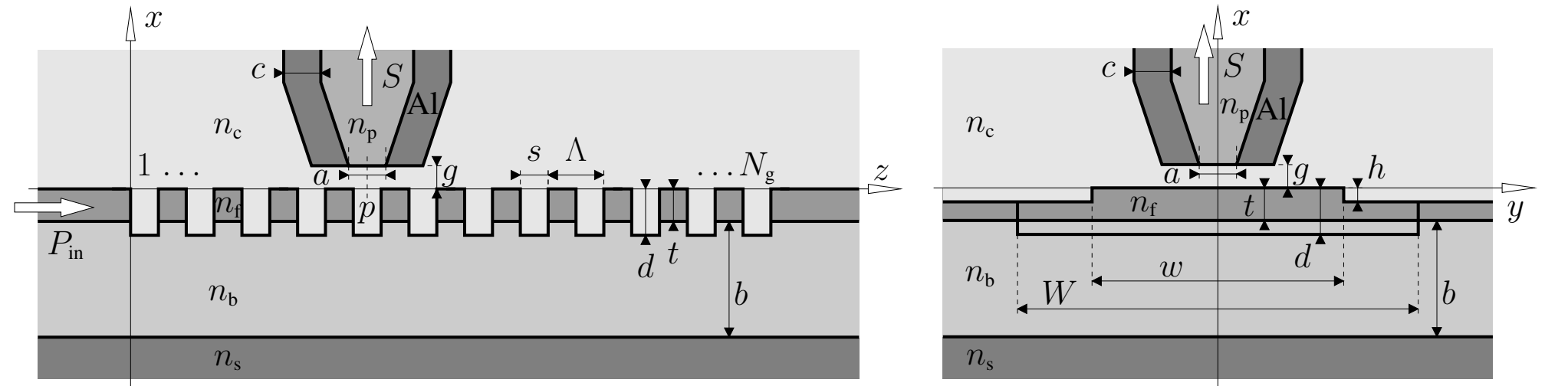


Resonant defect cavity



Resonant defect cavity



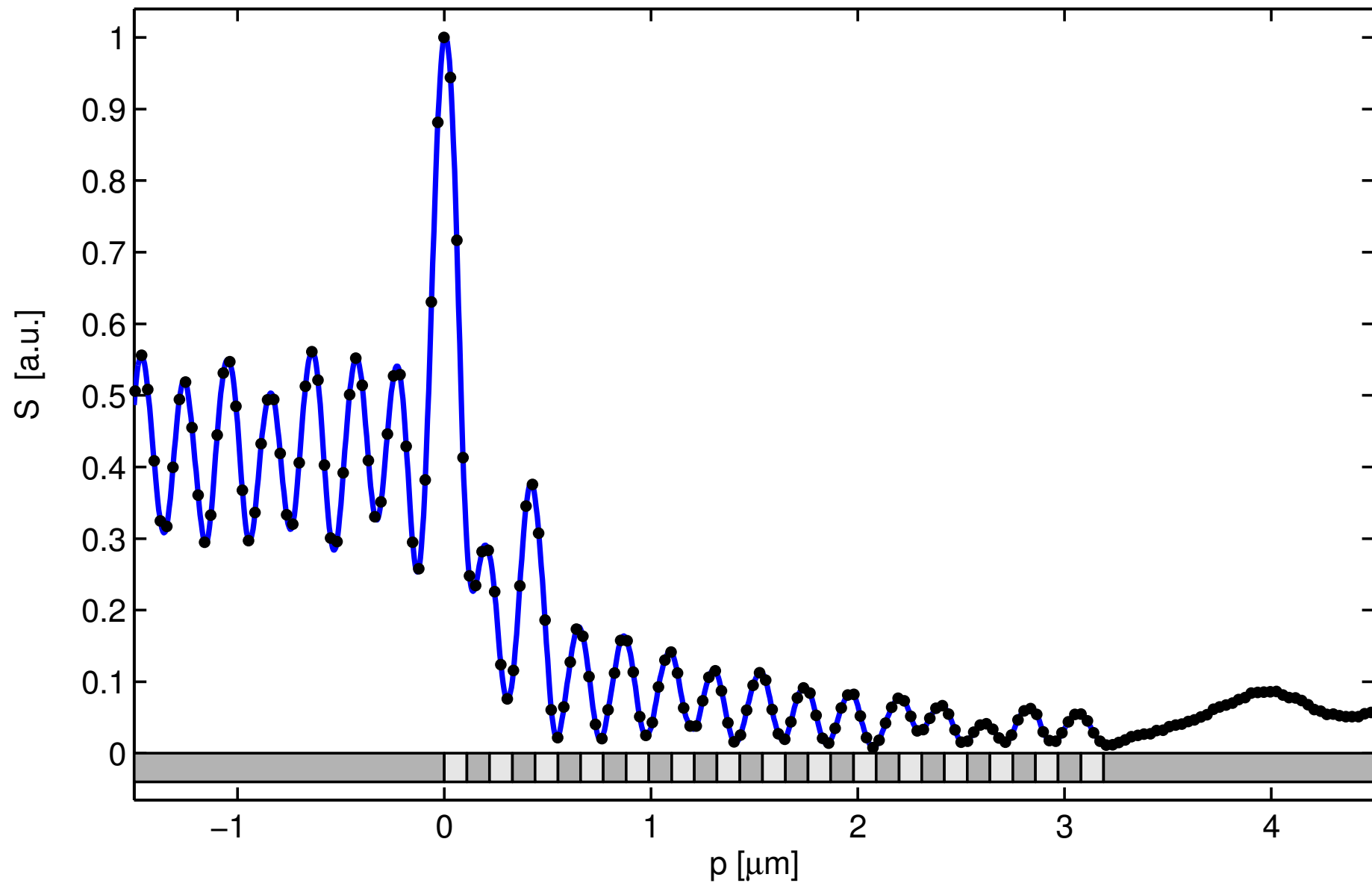


Sample: Rib waveguide with a series of deep, rectangular slits,
 $n_s = 3.4$, $n_b = 1.45$, $n_f = 2.01$, $n_c = 1.0$, $t = 55$ nm, $h = 11$ nm, $w = 1.5$ μ m,
 $W = 2.5$ μ m, $b = 3.2$ μ m, $\Lambda = 220$ nm, $s = 110$ nm, $d = 70$ nm, $N_g = 15$.

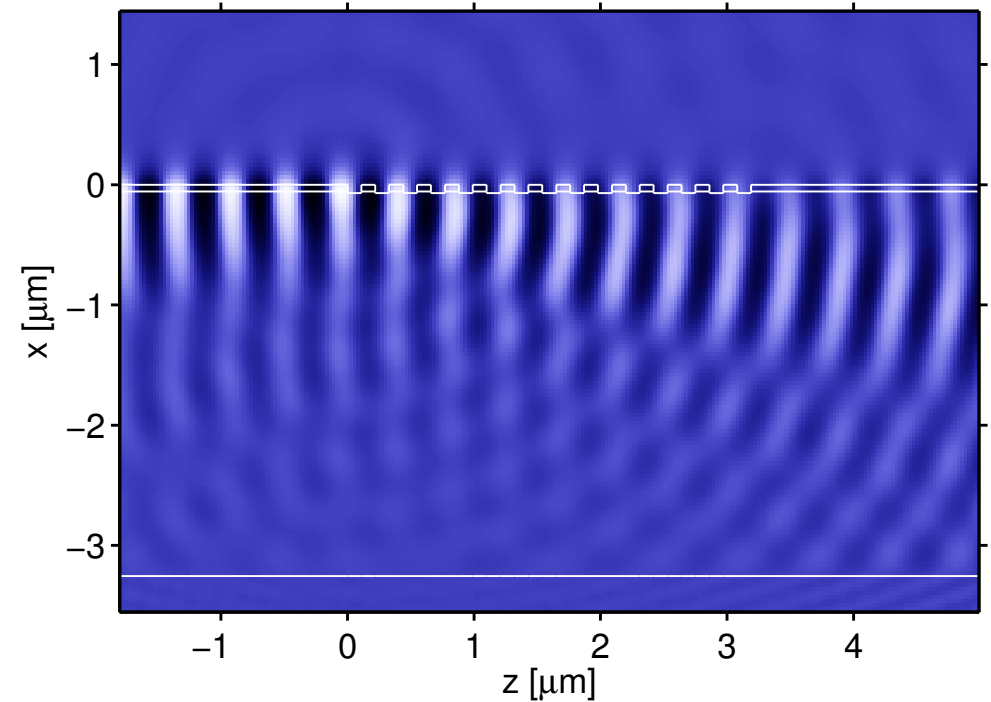
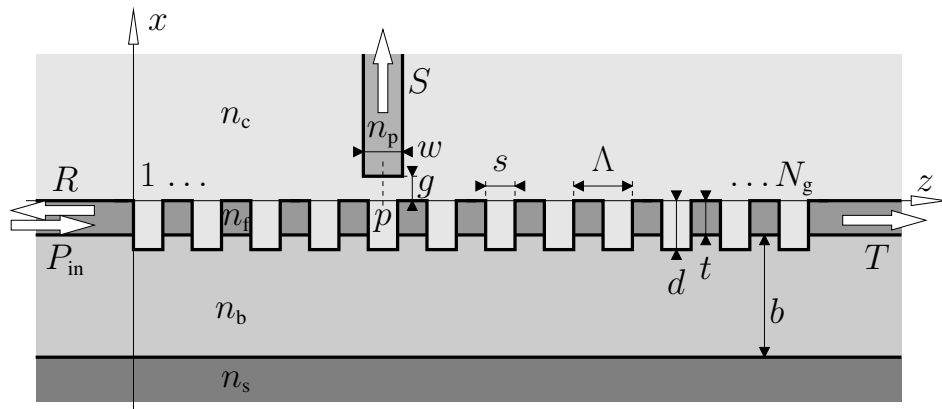
Probe: Tapered cylindrical fiber tip with aluminium coating,
 $a \approx 80$ nm, $c \approx 100$ nm, $g = 10$ nm, $n_p = 1.5$;
 TE polarized light, vacuum wavelength $\lambda = 0.6328$ μm .

* E. Flück, M. Hammer, A. M. Otter, J. P. Korterijk, L. Kuipers, N. F. van Hulst, *Amplitude and phase evolution of optical fields inside periodic photonic structures*, Journal of Lightwave Technology **21**(5), 1384-1393 (2003)

Bragg grating: PSTM experiment

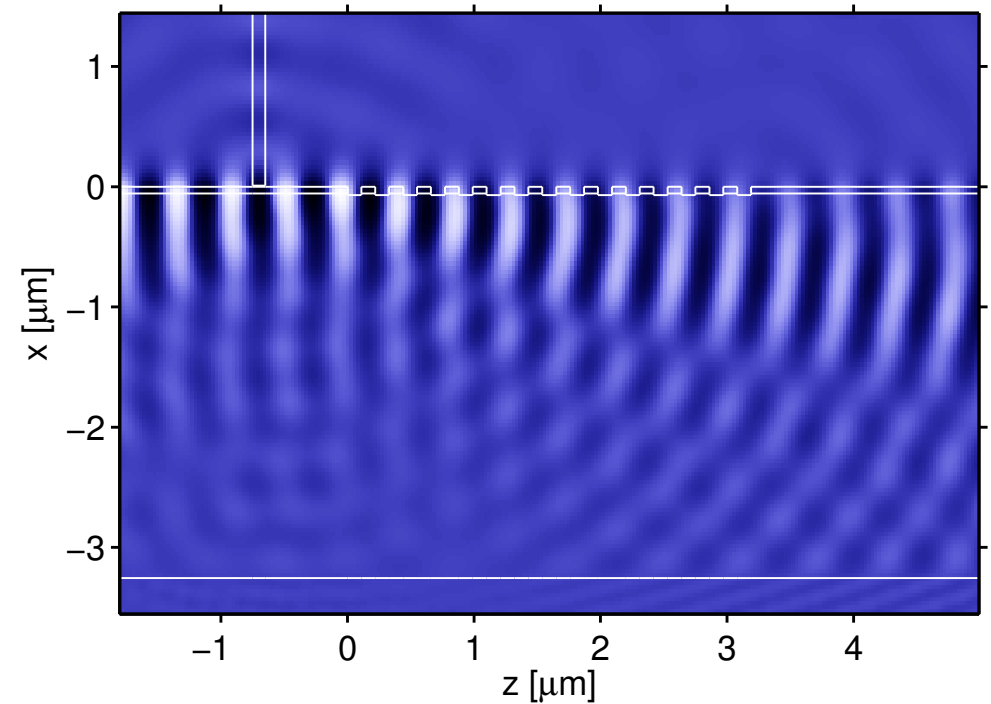
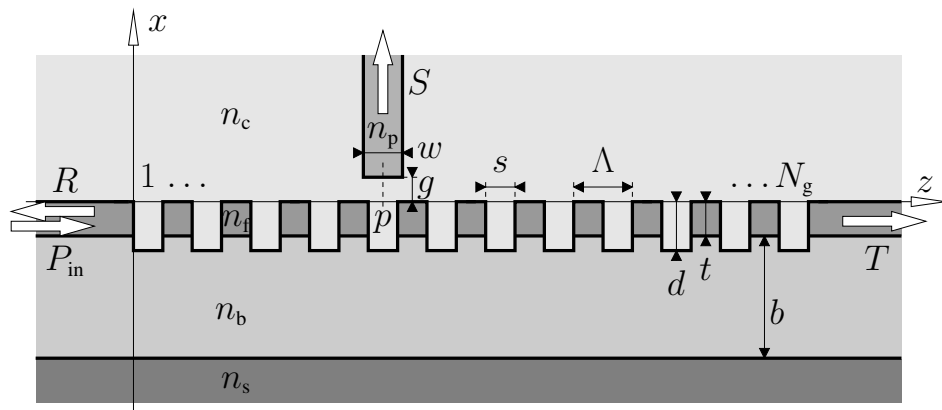


Bragg grating: QUEP model



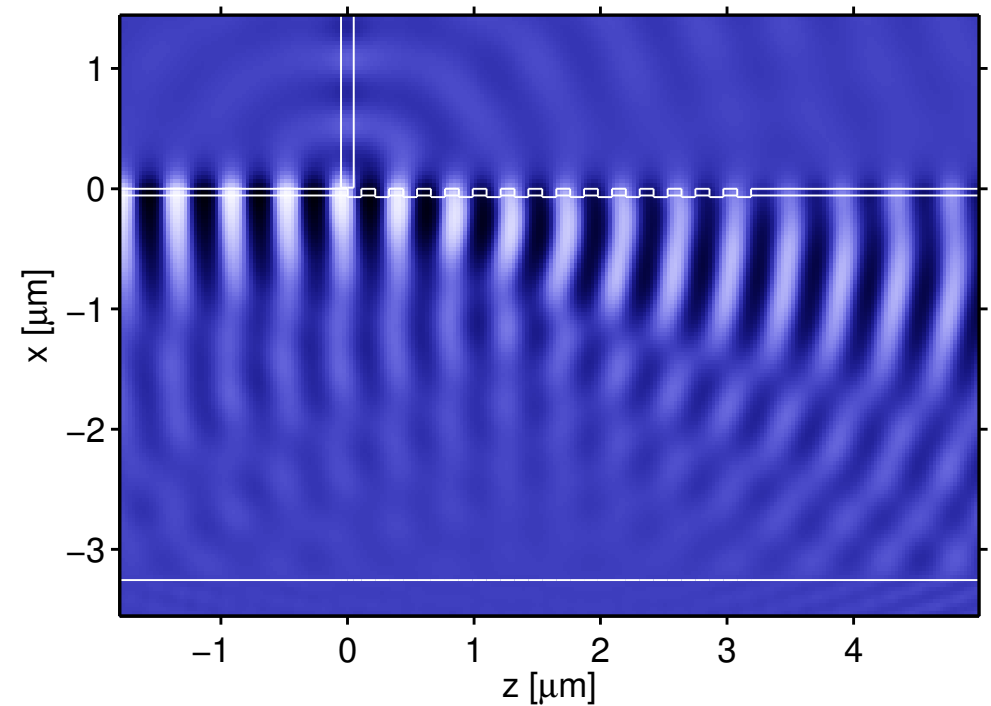
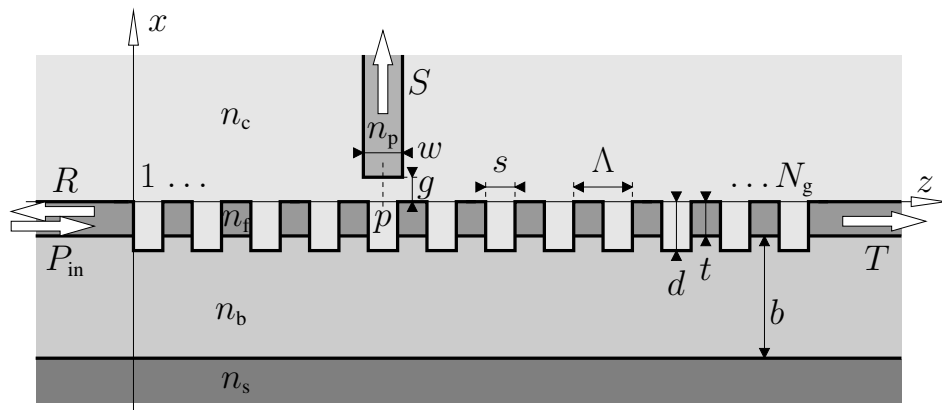
$n_s = 3.4, n_b = 1.45, n_f = 2.01, n_c = 1.0, t = 55 \text{ nm}, b = 3.2 \mu\text{m}, d = 70 \text{ nm},$
 $\Lambda = 220 \text{ nm}, s = 110 \text{ nm}, N_g = 15, g = 10 \text{ nm}, w = 100 \text{ nm}, n_p = 1.5,$
 $\text{TE}, \lambda = 0.6328 \mu\text{m}, (x, z) \in [-3.5, 1.5] \times [-2.0, 5.2] \mu\text{m}^2, M_x = 80, M_z = 100.$

Bragg grating: QUEP model



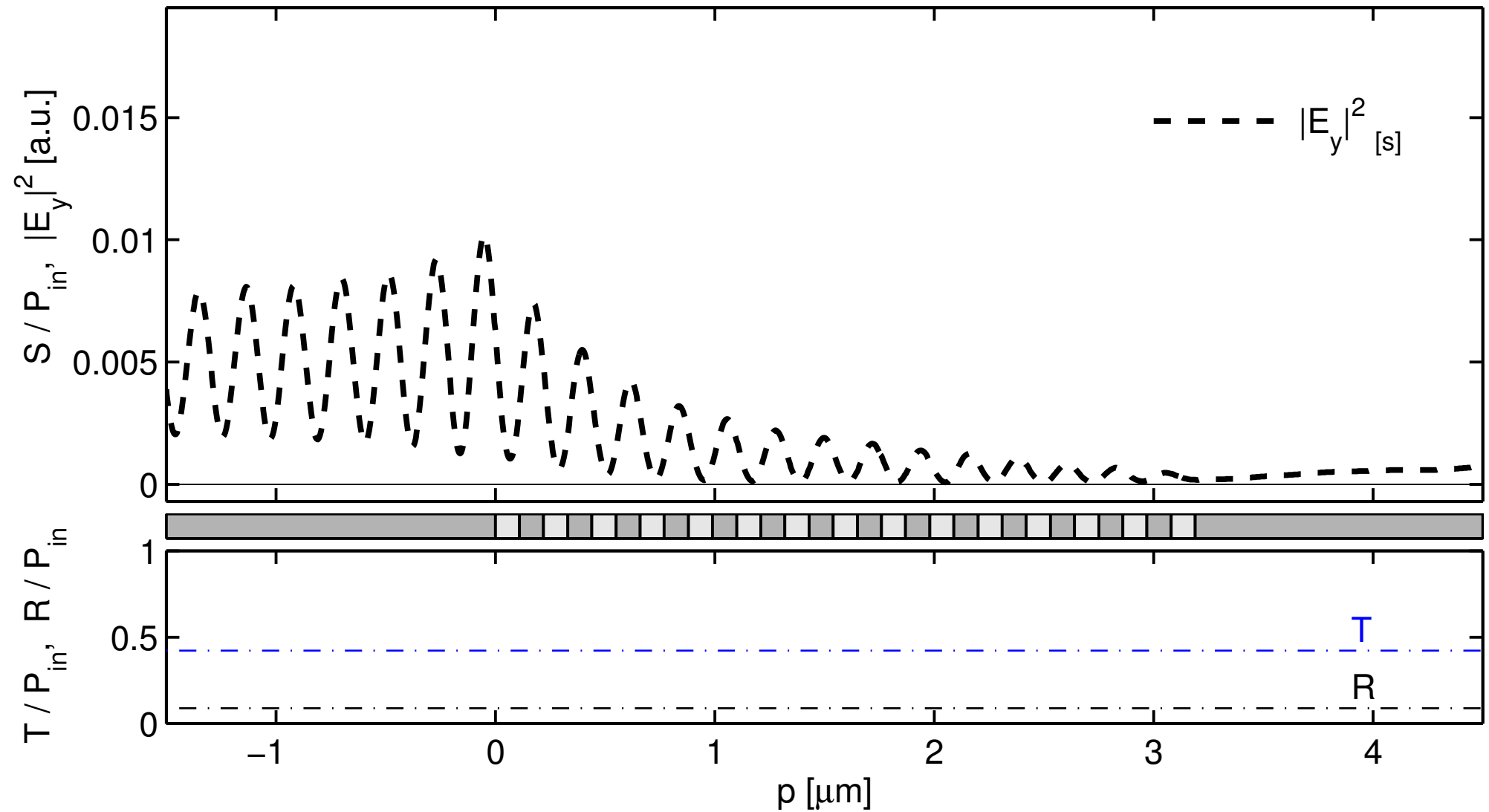
$n_s = 3.4, n_b = 1.45, n_f = 2.01, n_c = 1.0, t = 55 \text{ nm}, b = 3.2 \mu\text{m}, d = 70 \text{ nm},$
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Bragg grating: QUEP model

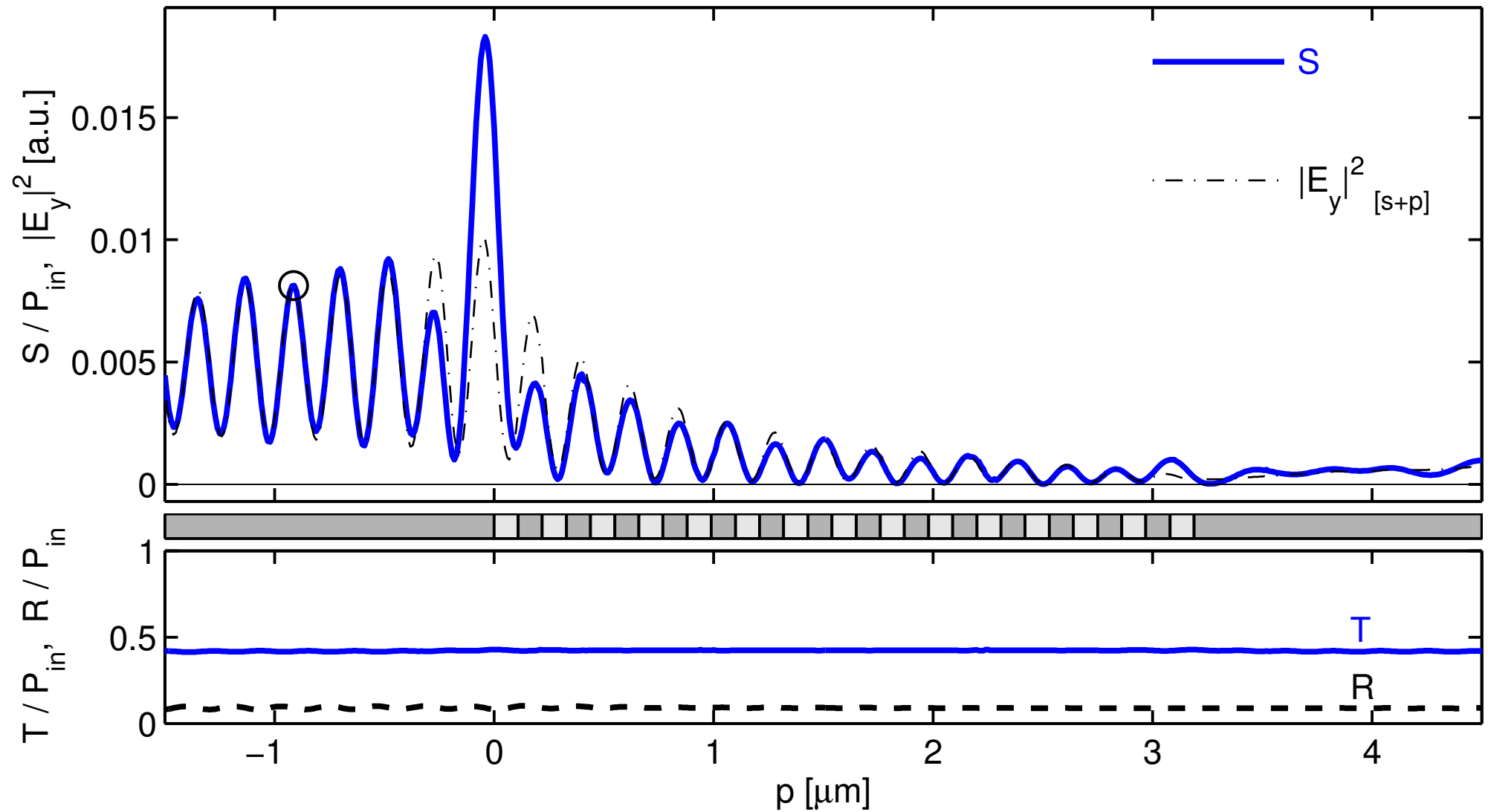


$n_s = 3.4, n_b = 1.45, n_f = 2.01, n_c = 1.0, t = 55 \text{ nm}, b = 3.2 \mu\text{m}, d = 70 \text{ nm},$
 $\Lambda = 220 \text{ nm}, s = 110 \text{ nm}, N_g = 15, g = 10 \text{ nm}, w = 100 \text{ nm}, n_p = 1.5,$
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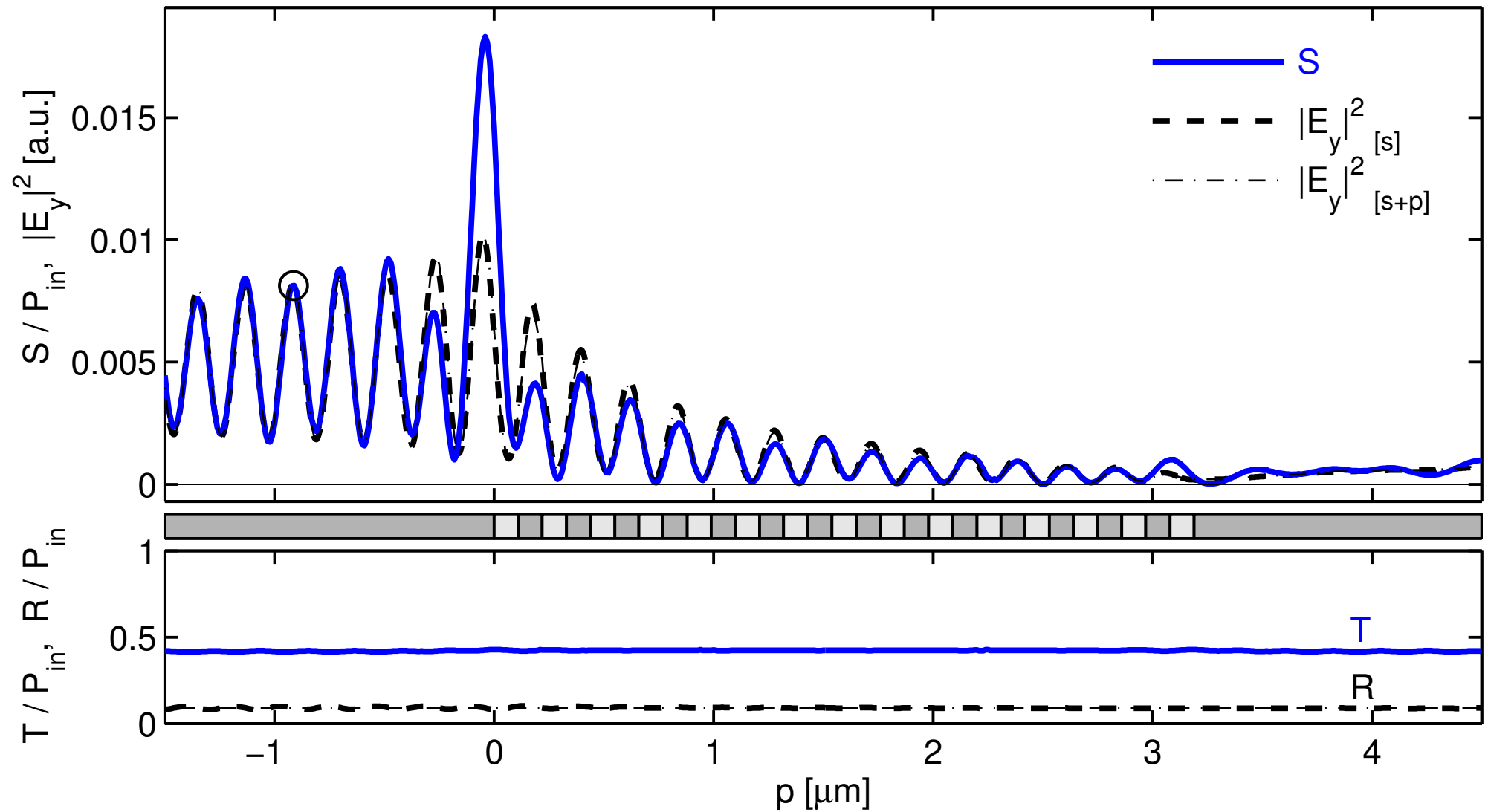
Bragg grating: QUEP model



Bragg grating: QUEP model



Bragg grating: QUEP model



2-D PSTM modeling

QUEP scheme:

a semianalytical quadridirectional eigenmode expansion technique, here applied as convenient tool for “virtual” PSTM experiments:

- Evanescent field probing, signal $\propto |E|^2$.
- Direct scattering into the probe tip.
- Resonance breakdown caused by the presence of the probe.
- Reasonable mapping of evanescent fields for specific configurations.
- Ample qualitative agreement with real PSTM experiments on a waveguide Bragg grating.

